

TPS51200 灌电流和拉电流 DDR 终端稳压器

1 特性

- 输入电压：支持 2.5V 和 3.3V 电源轨
- VLDOIN 电压范围：1.1V 至 3.5V
- 具有压降补偿功能的灌电流和拉电流终端稳压器
- 需要超小的输出电容 20 μ F（通常为 $3 \times 10\mu\text{F}$ MLCC），即可用于存储器终端应用 (DDR)
- 用于监视输出稳压的 PGOOD
- EN 输入
- REFIN 输入允许直接或通过电阻分压器灵活进行输入跟踪
- 远程检测 (VOSNS)
- $\pm 10\text{mA}$ 缓冲基准 (REFOUT)
- 内置软启动，欠压锁定 (UVLO) 和过流限制 (OCL)
- 热关断
- 支持 DDR、DDR2、DDR3、DDR3L、低功耗 DDR3 和 DDR4 VTT 应用
- 带有散热焊盘的 10 引脚超薄小外形尺寸无引线 (VSON) 封装

2 应用

- 用于 DDR、DDR2、DDR3、DDR3L、低功耗 DDR3 和 DDR4 的存储器终端稳压器
- 笔记本、台式机和服务器
- 电信和数据通信
- 基站
- 液晶 (LCD) 电视和等离子 (PDP) 电视
- 复印机和打印机
- 机顶盒

3 说明

TPS51200 器件是一款灌电流和拉电流双倍数据速率 (DDR) 终端稳压器，专门针对低输入电压、低成本、低噪声的空间受限型系统而设计。

TPS51200 可保持快速的瞬态响应，仅需 20 μ F 超低输出电容。TPS51200 支持遥感功能，并满足 DDR、DDR2、DDR3、DDR3L、低功耗 DDR3 和 DDR4 VTT 总线终端的所有电源要求。

此外，TPS51200 还提供一个开漏 PGOOD 信号来监测输出稳压，并提供一个 EN 信号在 S3（挂起至 RAM）期间针对 DDR 应用对 VTT 进行放电。

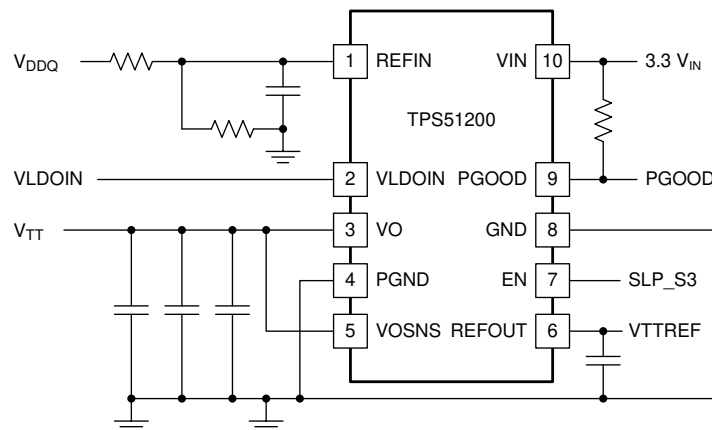
TPS51200 采用带散热焊盘的高效散热型 10 引脚 VSON 封装，具有绿色环保和无铅的特性。其额定温度范围为 -40°C 至 $+85^{\circ}\text{C}$ 。

器件信息⁽¹⁾

器件型号	封装	封装尺寸（标称值）
TPS51200	VSON (10)	3.00mm $\times$ 3.00mm

(1) 如需了解所有可用封装，请参阅数据表末尾的可订购产品附录。

简化的 DDR 应用



Copyright © 2016, Texas Instruments Incorporated



目录

1	特性	1	8	Application and Implementation	17
2	应用	1	8.1	Application Information	17
3	说明	1	8.2	Typical Application	17
4	修订历史记录	2	8.3	System Examples	20
5	Pin Configuration and Functions	3	9	Power Supply Recommendations	26
6	Specifications	4	10	Layout	26
6.1	Absolute Maximum Ratings	4	10.1	Layout Guidelines	26
6.2	ESD Ratings	4	10.2	Layout Example	27
6.3	Recommended Operating Conditions	4	10.3	Thermal Design Considerations	27
6.4	Thermal Information	4	11	器件和文档支持	29
6.5	Electrical Characteristics	5	11.1	器件支持	29
6.6	Typical Characteristics	7	11.2	文档支持	29
7	Detailed Description	10	11.3	社区资源	29
7.1	Overview	10	11.4	商标	29
7.2	Functional Block Diagram	10	11.5	静电放电警告	29
7.3	Feature Description	10	11.6	Glossary	29
7.4	Device Functional Modes	16	12	机械、封装和可订购信息	29

4 修订历史记录

注：之前版本的页码可能与当前版本有所不同。

Changes from Revision C (November 2016) to Revision D Page

•	Added "keep total REFOUT capacitance below 0.47 μ F" in Pin Functions table	3
---	---	----------

Changes from Revision B (September 2016) to Revision C Page

•	已添加 通篇添加了对 DDR3L DRAM 技术的引用	1
•	Added DDR3L test conditions to <i>Output DC voltage</i> , <i>VO</i> and <i>REFOUT</i> specification	5
•	Added Figure 4	7
•	Added Figure 9	8
•	Updated Figure 16 to include DDR3L data	9

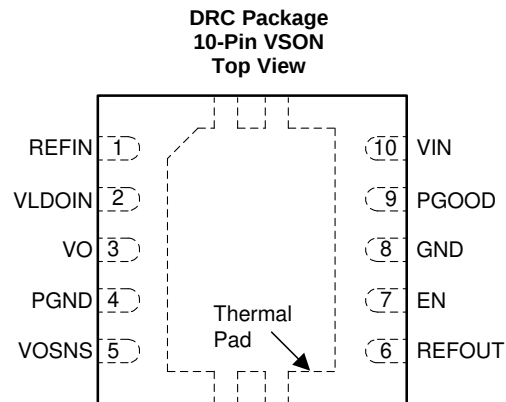
Changes from Revision A (September 2015) to Revision B Page

•	Changed " $-10\text{ mA} < I_{\text{REFOUT}} < 10\text{ mA}$ " to " $-1\text{ mA} < I_{\text{REFOUT}} < 1\text{ mA}$ " in all test conditions for the <i>REFOUT voltage tolerance to V_{REFIN}</i> specification	6
•	Changed all MIN and MAX values from "15" to "12" for all test conditions for the <i>REFOUT voltage tolerance to V_{REFIN}</i> specification	6
•	Updated Figure 19	11
•	Added <i>REFOUT (V_{REF}) Consideration for DDR2 Applications</i> section	15
•	Updated Figure 28 and Table 3	20
•	Added clarity to <i>Layout Guidelines</i> section.	26

Changes from Original (February 2008) to Revision A Page

•	已添加 添加了引脚配置和功能 部分、 <i>ESD</i> 额定值 表、特性 说明 部分、器件功能模式、应用和 实施 部分、电源相关建议 部分、布局 部分、器件和文档支持 部分以及机械、封装和可订购信息 部分	1
•	Changed "PowerPAD" references to "thermal pad" throughout	3
•	Deleted <i>Dissipation Ratings</i> table	4

5 Pin Configuration and Functions



Pin Functions

PIN		I/O ⁽¹⁾	DESCRIPTION
NAME	NO.		
EN	7	I	For DDR VTT application, connect EN to SLP_S3. For any other application, use the EN pin as the ON/OFF function.
GND	8	G	Signal ground.
PGND ⁽²⁾	4	G	Power ground for the LDO.
PGOOD	9	O	Open-drain, power-good indicator.
REFIN	1	I	Reference input.
REFOUT	6	O	Reference output. Connect to GND through 0.1- μ F ceramic capacitor. If there is a REFOUT capacitors at DDR side, keep total capacitance on REFOUT pin below 0.47 μ F. The REFOUT pin can not be open.
VIN	10	I	2.5-V or 3.3-V power supply. A ceramic decoupling capacitor with a value between 1- μ F and 4.7- μ F is required.
VLDOIN	2	I	Supply voltage for the LDO.
VO	3	O	Power output for the LDO.
VOSNS	5	I	Voltage sense input for the LDO. Connect to positive terminal of the output capacitor or the load.

(1) I = Input, O = Output, G = Ground

(2) Thermal pad connection. See [Figure 35](#) in the *Thermal Design Considerations* section for additional information.

6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted) ⁽¹⁾

		MIN	MAX	UNIT
Input voltage ⁽²⁾	REFIN, VIN, VLDOIN, VOSNS	−0.3	3.6	V
	EN	−0.3	6.5	
	PGND to GND	−0.3	0.3	
Output voltage ⁽²⁾	REFOUT, VO	−0.3	3.6	V
	PGOOD	−0.3	6.5	
Operating junction temperature, T _J		−40	150	°C
Storage temperature, T _{stg}		−55	150	°C

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) All voltage values are with respect to the network ground terminal unless otherwise noted.

6.2 ESD Ratings

		VALUE	UNIT
V _(ESD) Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	±2000	V
	Charged-device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾	±500	

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
Supply voltages	VIN	2.375		3.500	V
Voltage	EN, VLDOIN, VOSNS	−0.1		3.5	V
	REFIN	0.5		1.8	
	PGOOD, VO	−0.1		3.5	
	REFOUT	−0.1		1.8	
	PGND	−0.1		0.1	
Operating free-air temperature, T _A		−40		85	°C

6.4 Thermal Information

THERMAL METRIC ⁽¹⁾		TPS51200	UNIT
		DRC (VSON)	
		10 PINS	
R _{θJA}	Junction-to-ambient thermal resistance	55.6	°C/W
R _{θJC(top)}	Junction-to-case (top) thermal resistance	84.6	°C/W
R _{θJB}	Junction-to-board thermal resistance	30.0	°C/W
ψ _{JT}	Junction-to-top characterization parameter	5.5	°C/W
ψ _{JB}	Junction-to-board characterization parameter	30.1	°C/W
R _{θJC(bot)}	Junction-to-case (bottom) thermal resistance	10.9	°C/W

- (1) For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application report, [SPRA953](#).

6.5 Electrical Characteristics

Over recommended free-air temperature range, $V_{IN} = 3.3\text{ V}$, $V_{VLDOIN} = 1.8\text{ V}$, $V_{REFIN} = 0.9\text{ V}$, $V_{VOSNS} = 0.9\text{ V}$, $V_{EN} = V_{VIN}$, $C_{OUT} = 3 \times 10\text{ }\mu\text{F}$ and circuit shown in Figure 24. (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
SUPPLY CURRENT						
I_{IN}	Supply current	$T_A = 25\text{ }^\circ\text{C}$, $V_{EN} = 3.3\text{ V}$, No Load		0.7	1	mA
$I_{IN(SDN)}$	Shutdown current	$T_A = 25\text{ }^\circ\text{C}$, $V_{EN} = 0\text{ V}$, $V_{REFIN} = 0$, No Load		65	80	μA
		$T_A = 25\text{ }^\circ\text{C}$, $V_{EN} = 0\text{ V}$, $V_{REFIN} > 0.4\text{ V}$, No Load		200	400	
I_{LDOIN}	Supply current of VLDOIN	$T_A = 25\text{ }^\circ\text{C}$, $V_{EN} = 3.3\text{ V}$, No Load		1	50	μA
$I_{LDOIN(SDN)}$	Shutdown current of VLDOIN	$T_A = 25\text{ }^\circ\text{C}$, $V_{EN} = 0\text{ V}$, No Load		0.1	50	μA
INPUT CURRENT						
I_{REFIN}	Input current, REFIN	$V_{EN} = 3.3\text{ V}$			1	μA
VO OUTPUT						
V_{VOSNS}	Output DC voltage, VO	$V_{REFOUT} = 1.25\text{ V}$ (DDR1), $I_O = 0\text{ A}$		1.25		V
			–15		15	mV
		$V_{REFOUT} = 0.9\text{ V}$ (DDR2), $I_O = 0\text{ A}$		0.9		V
			–15		15	mV
		$V_{REFOUT} = 0.75\text{ V}$ (DDR3), $I_O = 0\text{ A}$		0.75		V
			–15		15	mV
		$V_{REFOUT} = 0.675\text{ V}$ (DDR3L), $I_O = 0\text{ A}$		0.675		V
			–15		15	mV
		$V_{REFOUT} = 0.6\text{ V}$ (DDR4), $I_O = 0\text{ A}$		0.6		V
			–15		15	mV
V_{VOTOL}	Output voltage tolerance to REFOUT	$-2\text{ A} < I_{VO} < 2\text{ A}$	–25		25	mV
I_{VOSRCL}	VO source current Limit	With reference to REFOUT, $V_{OSNS} = 90\% \times V_{REFOUT}$	3		4.5	A
I_{VOSNCL}	VO sink current Limit	With reference to REFOUT, $V_{OSNS} = 110\% \times V_{REFOUT}$	3.5		5.5	A
I_{DSCHRG}	Discharge current, VO	$V_{REFIN} = 0\text{ V}$, $V_{VO} = 0.3\text{ V}$, $V_{EN} = 0\text{ V}$, $T_A = 25\text{ }^\circ\text{C}$		18	25	Ω
POWERGOOD COMPARATOR						
$V_{TH(PG)}$	VO PGOOD threshold	PGOOD window lower threshold with respect to REFOUT	–23.5%	–20%	–17.5%	
		PGOOD window upper threshold with respect to REFOUT	17.5%	20%	23.5%	
		PGOOD hysteresis		5%		
$t_{PGSTUPDLY}$	PGOOD start-up delay	Start-up rising edge, VOSNS within 15% of REFOUT		2		ms
$V_{PGOODLOW}$	Output low voltage	$I_{SINK} = 4\text{ mA}$			0.4	V
$t_{PBADDLY}$	PGOOD bad delay	VOSNS is outside of the $\pm 20\%$ PGOOD window		10		μs
$I_{PGOODLK}$	Leakage current ⁽¹⁾	$V_{OSNS} = V_{REFIN}$ (PGOOD high impedance), $V_{PGOOD} = V_{VIN} + 0.2\text{ V}$			1	μA
REFIN AND REFOUT						
V_{REFIN}	REFIN voltage range		0.5		1.8	V
$V_{REFINUVLO}$	REFIN undervoltage lockout	REFIN rising	360	390	420	mV
$V_{REFINUVHYS}$	REFIN undervoltage lockout hysteresis			20		mV
V_{REFOUT}	REFOUT voltage			REFIN		V

(1) Ensured by design. Not production tested.

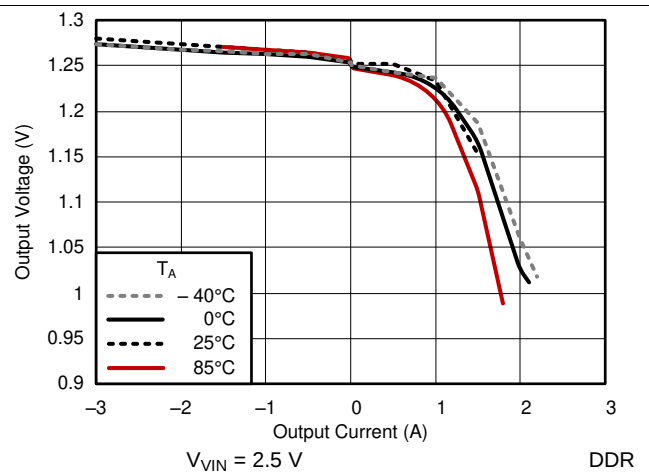
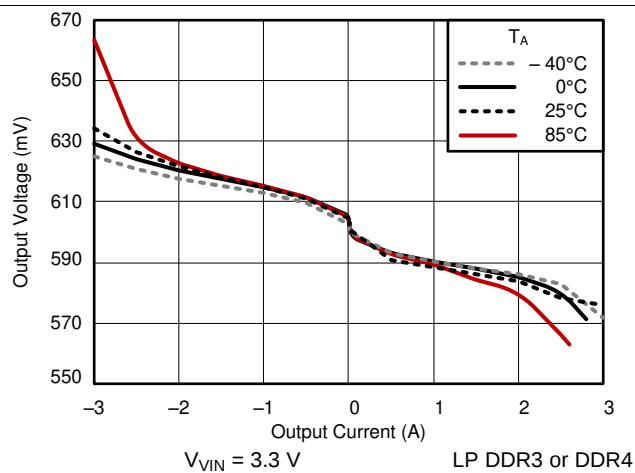
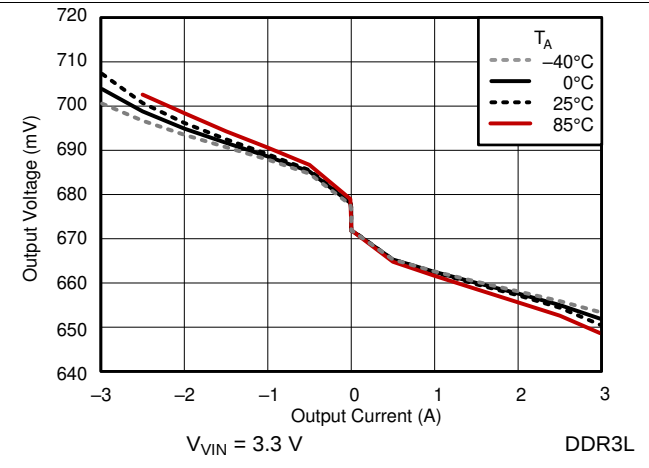
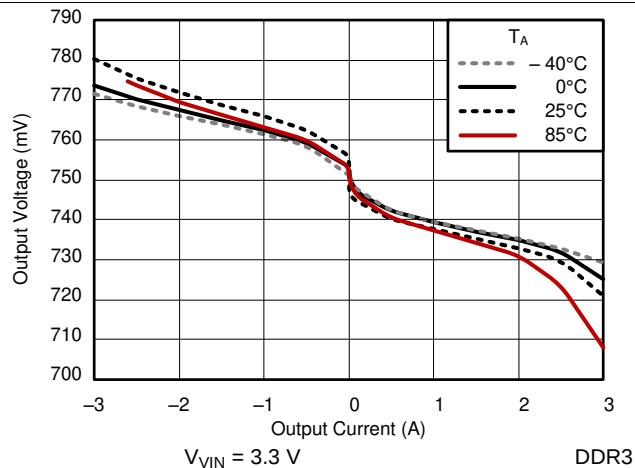
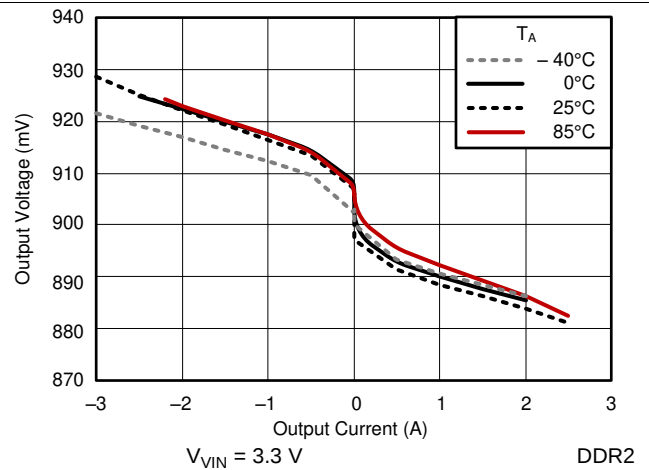
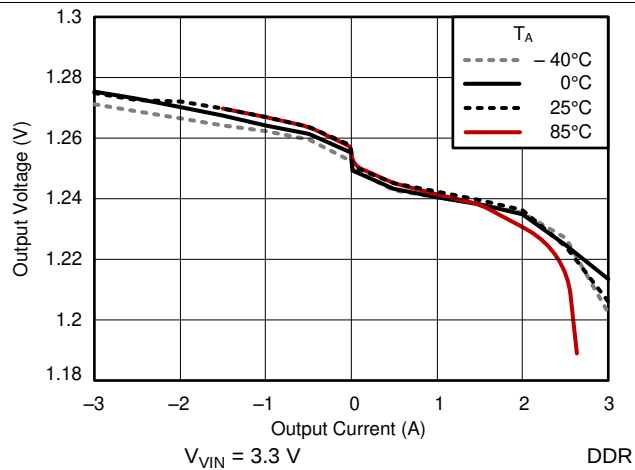
Electrical Characteristics (continued)

Over recommended free-air temperature range, $V_{VIN} = 3.3\text{ V}$, $V_{VLDIOIN} = 1.8\text{ V}$, $V_{REFIN} = 0.9\text{ V}$, $V_{VOSNS} = 0.9\text{ V}$, $V_{EN} = V_{VIN}$, $C_{OUT} = 3 \times 10\text{ }\mu\text{F}$ and circuit shown in [Figure 24](#). (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
$V_{REFOUTTOL}$ REFOUT voltage tolerance to V_{REFIN}	$-1\text{ mA} < I_{REFOUT} < 1\text{ mA}$, $V_{REFIN} = 1.25\text{ V}$	-12		12	mV
	$-1\text{ mA} < I_{REFOUT} < 1\text{ mA}$, $V_{REFIN} = 0.9\text{ V}$	-12		12	
	$-1\text{ mA} < I_{REFOUT} < 1\text{ mA}$, $V_{REFIN} = 0.75\text{ V}$	-12		12	
	$-1\text{ mA} < I_{REFOUT} < 1\text{ mA}$, $V_{REFIN} = 0.675\text{ V}$	-12		12	
	$-1\text{ mA} < I_{REFOUT} < 1\text{ mA}$, $V_{REFIN} = 0.6\text{ V}$	-12		12	
$I_{REFOUTSRCL}$ REFOUT source current limit	$V_{REFOUT} = 0\text{ V}$	10	40		mA
$I_{REFOUTSNCL}$ REFOUT sink current limit	$V_{REFOUT} = 0\text{ V}$	10	40		mA
UVLO AND EN LOGIC THRESHOLD					
$V_{VINUVVIN}$ UVLO threshold	Wake up, $T_A = 25^\circ\text{C}$	2.2	2.3	2.375	V
	Hysteresis		50		mV
V_{ENIH} High-level input voltage	Enable	1.7			V
V_{ENIL} Low-level input voltage	Enable			0.3	
V_{ENYST} Hysteresis voltage	Enable		0.5		
I_{ENLEAK} Logic input leakage current	EN, $T_A = 25^\circ\text{C}$	-1		1	μA
THERMAL SHUTDOWN					
T_{SON} Thermal shutdown threshold ⁽¹⁾	Shutdown temperature		150		$^\circ\text{C}$
	Hysteresis		25		

6.6 Typical Characteristics

3 × 10-μF MLCCs (0805) are used on the output



Typical Characteristics (continued)

3 × 10-μF MLCCs (0805) are used on the output

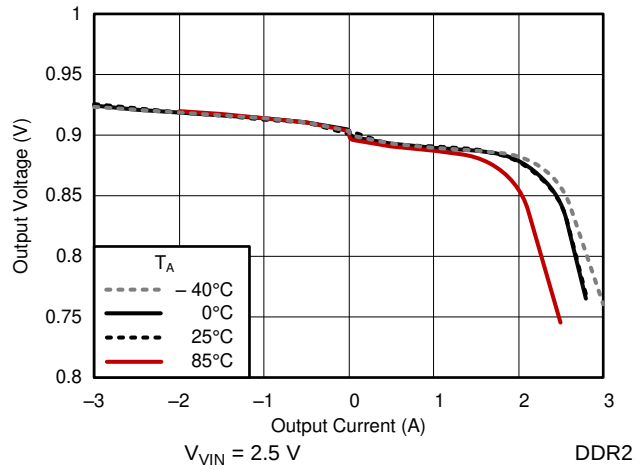


Figure 7. Load Regulation

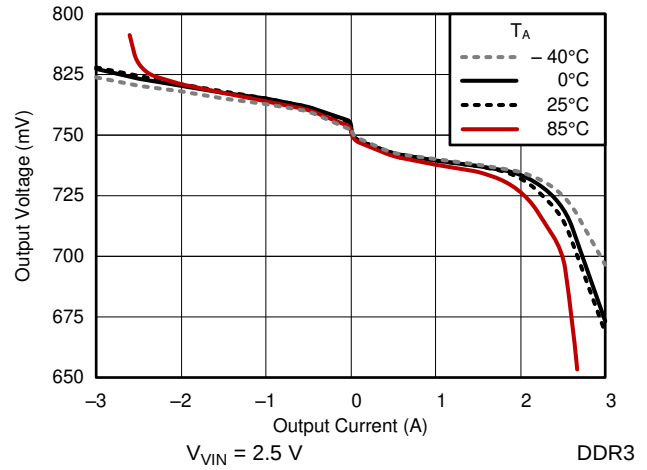


Figure 8. Load Regulation

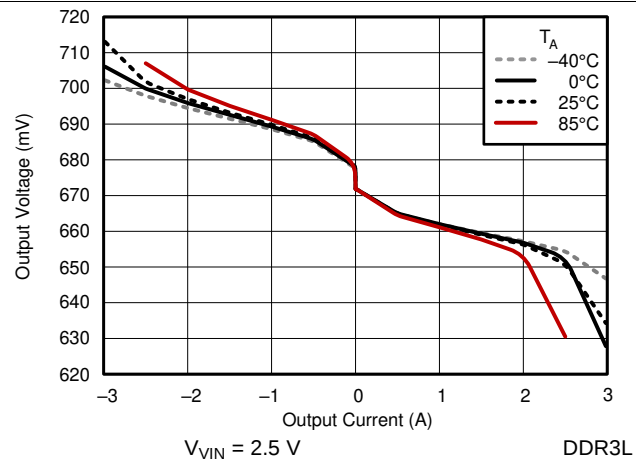


Figure 9. Load Regulation

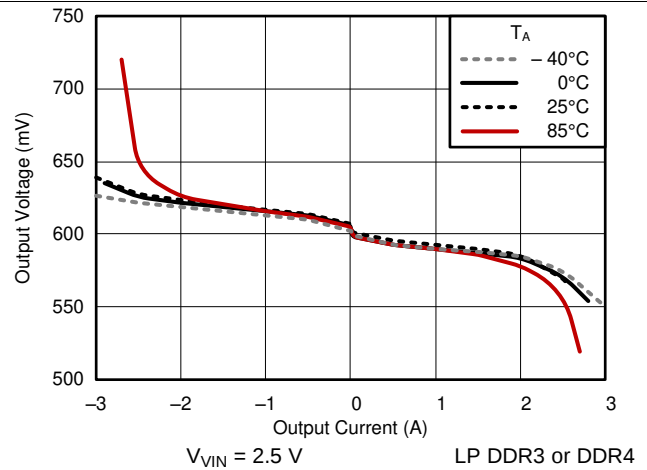


Figure 10. Load Regulation

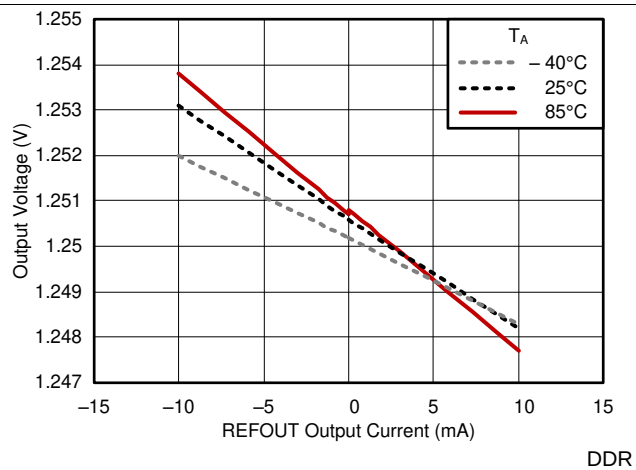


Figure 11. REFOUT Load Regulation

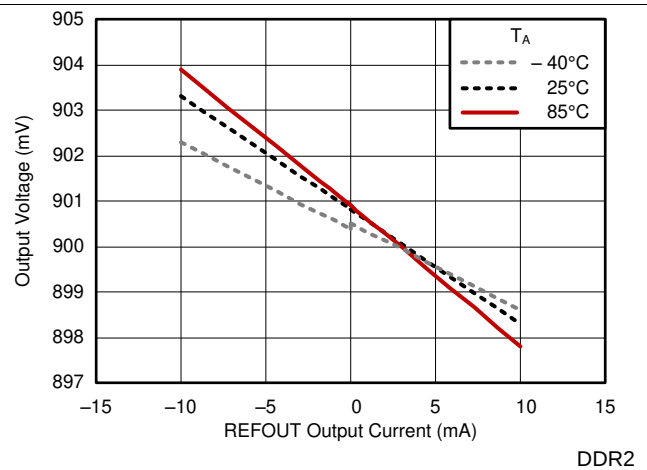


Figure 12. REFOUT Load Regulation

Typical Characteristics (continued)

3 × 10-μF MLCCs (0805) are used on the output

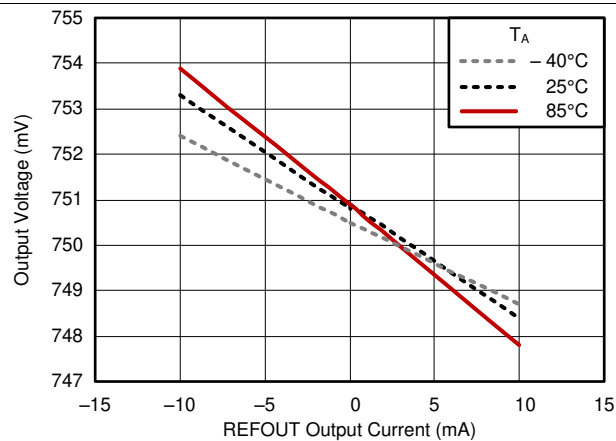


Figure 13. REFOUT Load Regulation

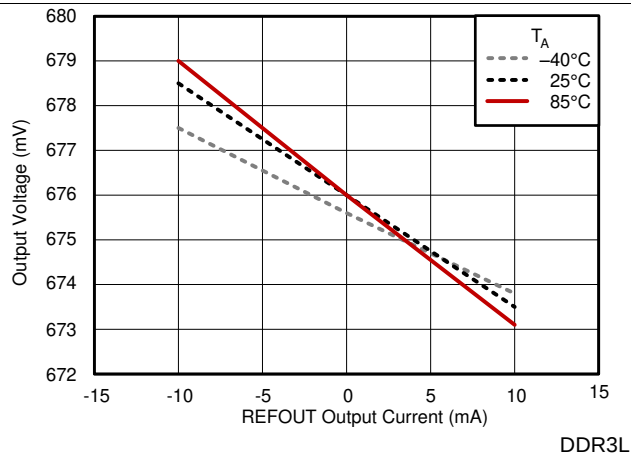


Figure 14. REFOUT Load Regulation

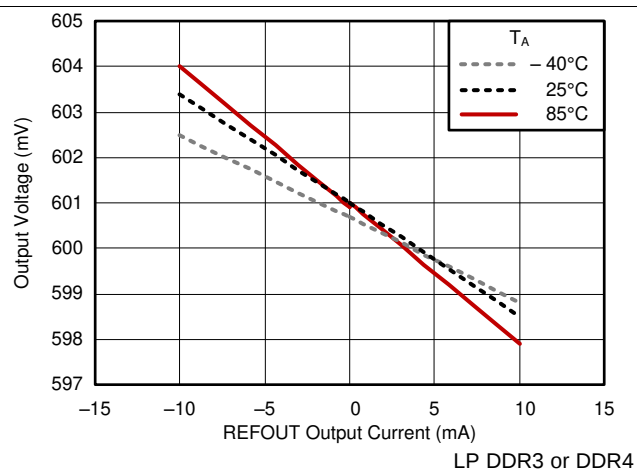


Figure 15. REFOUT Load Regulation

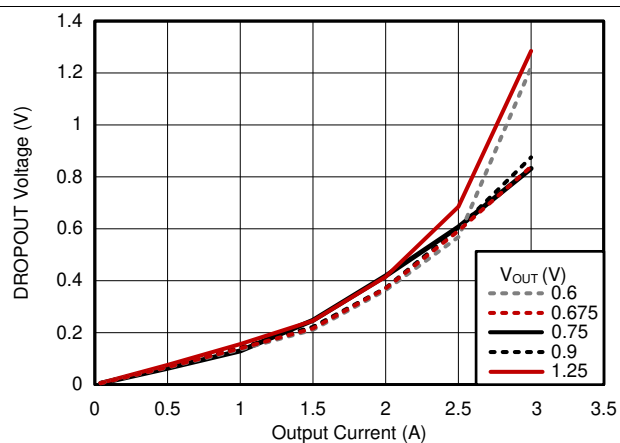


Figure 16. DROPOUT Voltage vs. Output Current

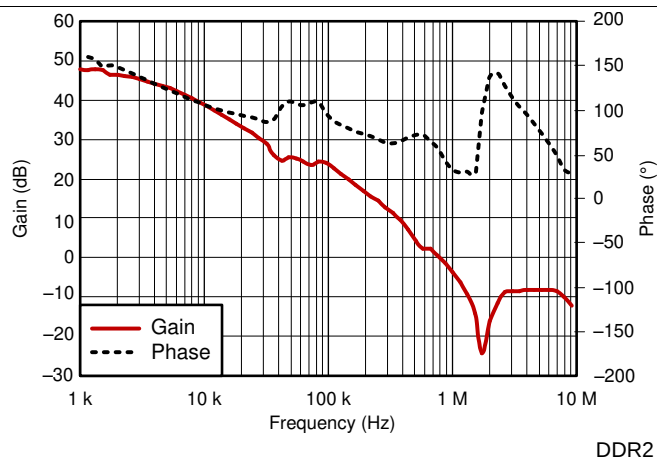


Figure 17. Bode Plot

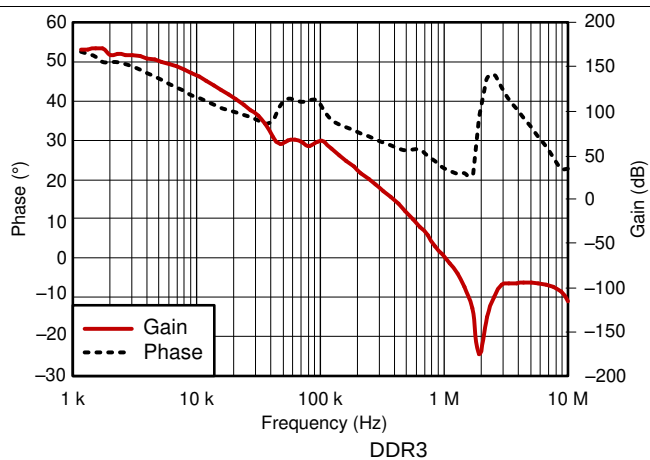


Figure 18. Bode Plot

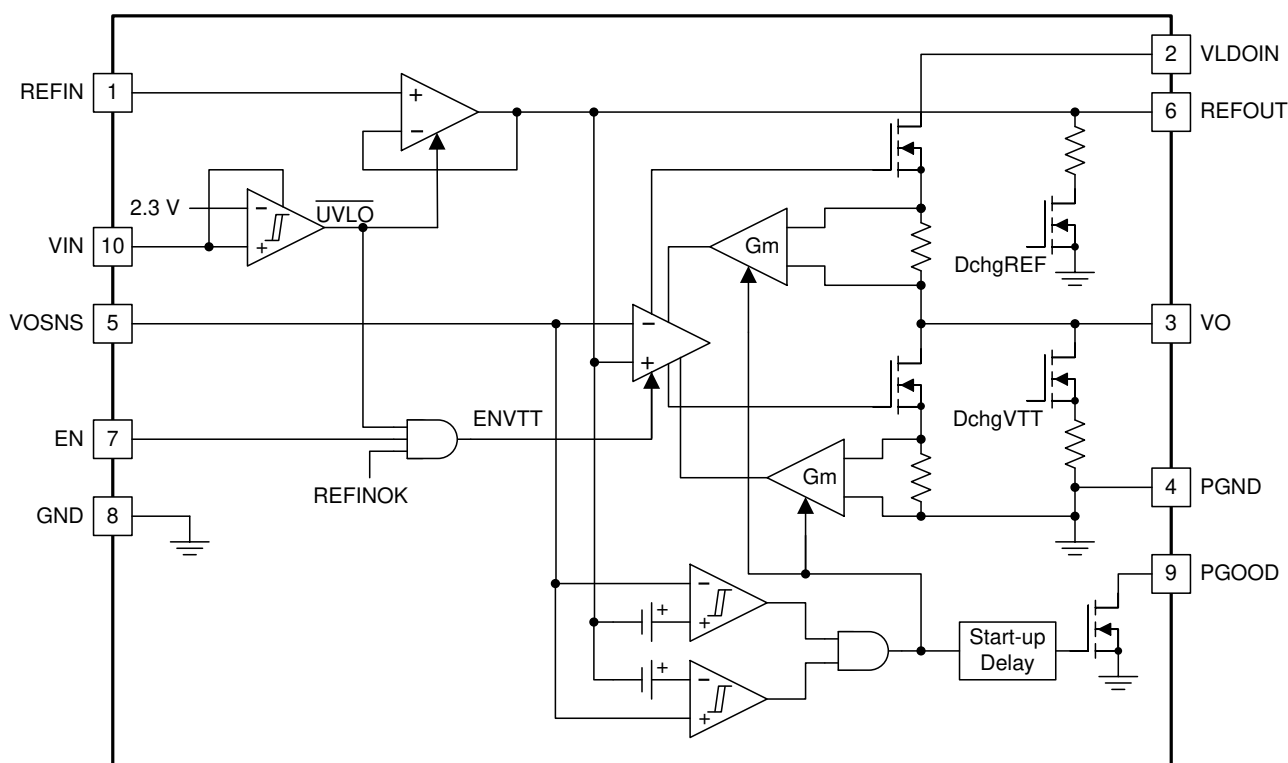
7 Detailed Description

7.1 Overview

The TPS51200 device is a sink and source double data rate (DDR) termination regulator specifically designed for low input voltage, low-cost, low-noise systems where space is a key consideration.

The device maintains a fast transient response and only requires a minimum output capacitance of 20 μF . The device supports a remote sensing function and all power requirements for DDR, DDR2, DDR3, DDR3L, Low Power DDR3, and DDR4 VTT bus termination.

7.2 Functional Block Diagram



Copyright © 2016, Texas Instruments Incorporated

7.3 Feature Description

7.3.1 Sink and Source Regulator (VO Pin)

The TPS51200 is a sink and source tracking termination regulator specifically designed for low input voltage, low-cost, and low external component count systems where space is a key application parameter. The device integrates a high-performance, low-dropout (LDO) linear regulator that is capable of both sourcing and sinking current. The LDO regulator employs a fast feedback loop so that small ceramic capacitors can be used to support the fast load transient response. To achieve tight regulation with minimum effect of trace resistance, connect a remote sensing terminal, VOSNS, to the positive terminal of each output capacitor as a separate trace from the high current path from VO.

7.3.2 Reference Input (REFIN Pin)

The output voltage, VO, is regulated to REFOUT. When REFIN is configured for standard DDR termination applications, REFIN can be set by an external equivalent ratio voltage divider connected to the memory supply bus (VDDQ). The TPS51200 device supports REFIN voltages from 0.5 V to 1.8 V, making it versatile and ideal for many types of low-power LDO applications.

Feature Description (continued)

7.3.3 Reference Output (REFOUT Pin)

When it is configured for DDR termination applications, REFOUT generates the DDR VTT reference voltage for the memory application. It is capable of supporting both a sourcing and sinking load of 10 mA. REFOUT becomes active when REFIN voltage rises to 0.390 V and VIN is above the UVLO threshold. When REFOUT is less than 0.375 V, it is disabled and subsequently discharges to GND through an internal 10-kΩ MOSFET. REFOUT is independent of the EN pin state.

7.3.4 Soft-Start Sequencing

A current clamp implements the soft-start function of the VO pin. The current clamp allows the output capacitors to be charged with low and constant current, providing a linear ramp-up of the output voltage. When VO is outside of the powergood window, the current clamp level is one-half of the full overcurrent limit (OCL) level. When VO rises or falls within the PGOOD window, the current clamp level switches to the full OCL level. The soft-start function is completely symmetrical and the overcurrent limit works for both directions. The soft-start function works not only from GND to the REFOUT voltage, but also from VLDOIN to the REFOUT voltage.

7.3.5 Enable Control (EN Pin)

When EN is driven high, the VO regulator begins normal operation. When the device drives EN low, VO discharges to GND through an internal 18-Ω MOSFET. REFOUT remains on when the device drives EN low. Ensure that the EN pin voltage remains lower than or equal to V_{VIN} at all times.

7.3.6 Powergood Function (PGOOD Pin)

The TPS51200 device provides an open-drain PGOOD output that goes high when the VO output is within $\pm 20\%$ of REFOUT. PGOOD de-asserts within 10 μ s after the output exceeds the size of the powergood window. During initial VO start-up, PGOOD asserts high 2 ms (typ) after the VO enters power good window. Because PGOOD is an open-drain output, a pull-up resistor with a value between 1 kΩ and 100 kΩ, placed between PGOOD and a stable active supply voltage rail is required.

7.3.7 Current Protection (VO Pin)

The LDO has a constant overcurrent limit (OCL). The OCL level reduces by one-half when the output voltage is not within the powergood window. This reduction is a non-latch protection.

7.3.8 UVLO Protection (VIN Pin)

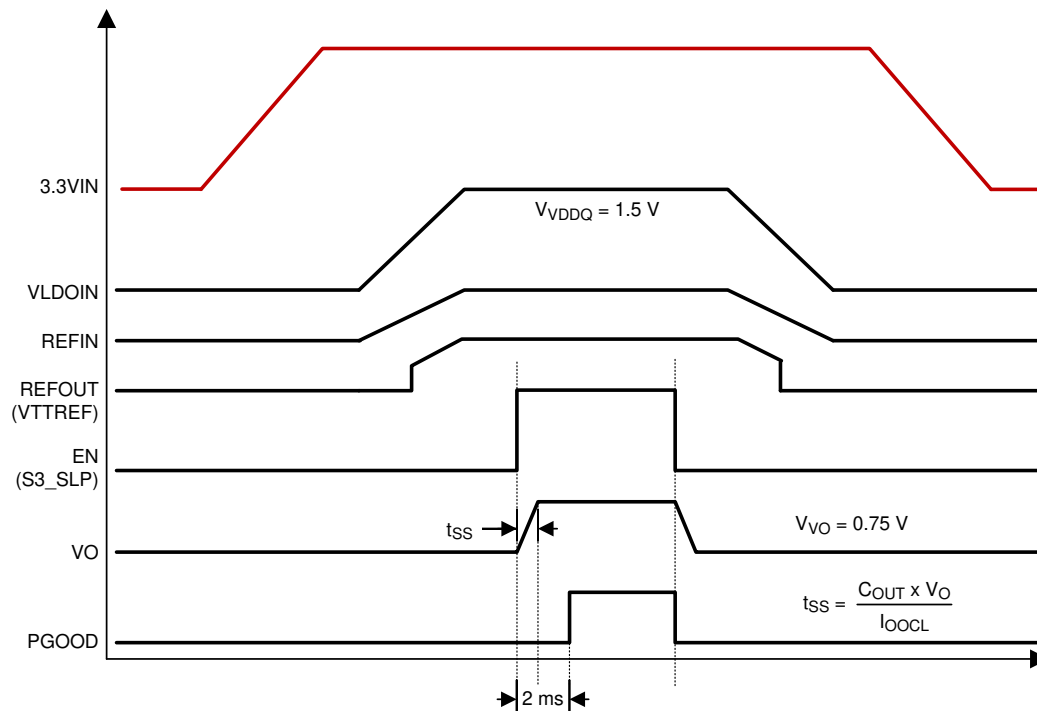
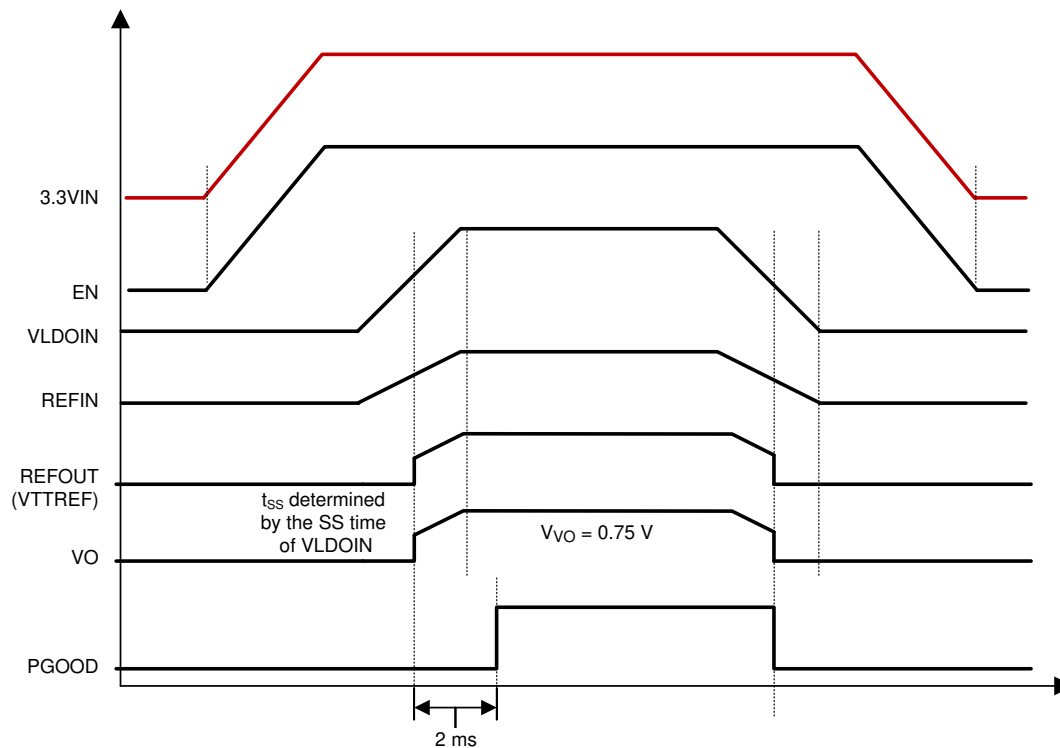
For VIN undervoltage lockout (UVLO) protection, the TPS51200 monitors VIN voltage. When the VIN voltage is lower than the UVLO threshold voltage, both the VO and REFOUT regulators are powered off. This shutdown is a non-latch protection.

7.3.9 Thermal Shutdown

The TPS51200 monitors junction temperature. If the device junction temperature exceeds the threshold value, (typically 150°C), the VO and REFOUT regulators both shut off, discharged by the internal discharge MOSFETs. This shutdown is a non-latch protection.

7.3.10 Tracking Start-up and Shutdown

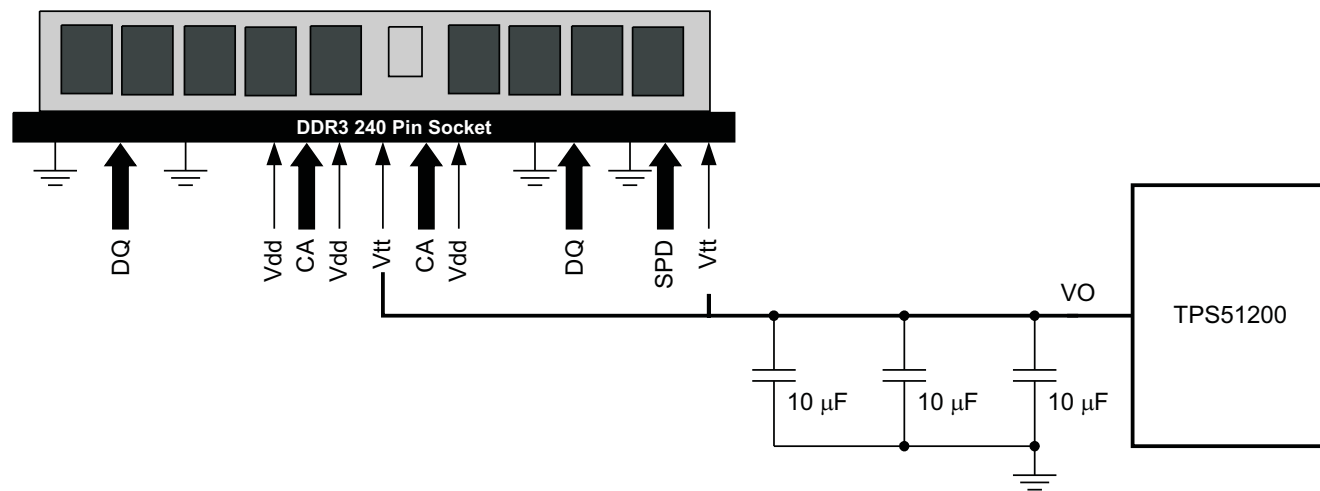
The TPS51200 also supports tracking start-up and shutdown when the EN pin is tied directly to the system bus and not used to turn on or turn off the device. During tracking start-up, VO follows REFOUT once REFIN voltage is greater than 0.39 V. REFIN follows the rise of VDDQ rail through a voltage divider. The typical soft-start time (t_{SS}) for the VDDQ rail is approximately 3 ms, however it may vary depending on the system configuration. The soft-start time of the VO output no longer depends on the OCL setting, but it is a function of the soft-start time of the VDDQ rail. PGOOD is asserted 2 ms after V_{VO} is within $\pm 20\%$ of REFOUT. During tracking shutdown, the VO pin voltage falls following REFOUT until REFOUT reaches 0.37 V. When REFOUT falls below 0.37 V, the internal discharge MOSFETs turn on and quickly discharge both REFOUT and VO to GND. PGOOD is deasserted when VO is beyond the $\pm 20\%$ range of REFOUT. [Figure 20](#) shows the typical timing diagram for an application that uses tracking start-up and shutdown.

Feature Description (continued)

Figure 19. Typical Timing Diagram for S3 and Pseudo-S5 Support

Figure 20. Typical Timing Diagram of Tracking Start-up and Shutdown

Feature Description (continued)

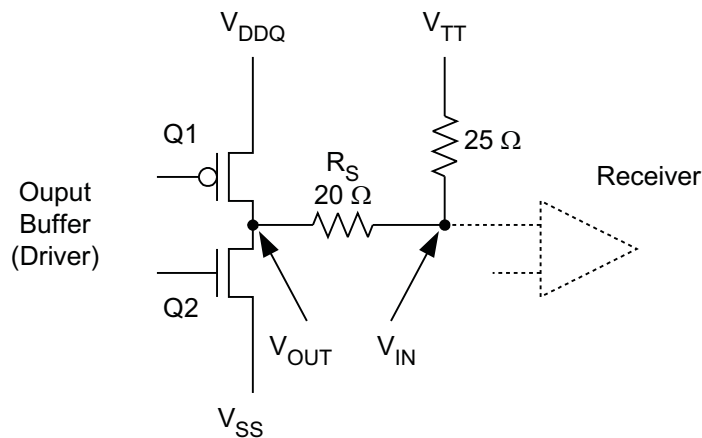
7.3.11 Output Tolerance Consideration for VTT DIMM Applications

The TPS51200 is specifically designed to power up the memory termination rail (as shown in Figure 21). The DDR memory termination structure determines the main characteristics of the VTT rail, which is to be able to sink and source current while maintaining acceptable VTT tolerance. See Figure 22 for typical characteristics for a single memory cell.



UDG-08022

Figure 21. Typical Application Diagram for DDR3 VTT DIMM using TPS51200



UDG-08023

Figure 22. DDR Physical Signal System Bi-Directional SSTL Signaling

In Figure 22, when Q1 is on and Q2 is off:

- Current flows from VDDQ via the termination resistor to VTT
- VTT sinks current

In Figure 22, when Q2 is on and Q1 is off:

- Current flows from VTT via the termination resistor to GND
- VTT sources current

Feature Description (continued)

Because VTT accuracy has a direct impact on the memory signal integrity, it is imperative to understand the tolerance requirement on VTT. Equation 1 applies to both DC and AC conditions and is based on JEDEC VTT specifications for DDR and DDR2 (JEDEC standard: DDR JESD8-9B May 2002; DDR2 JESD8-15A Sept 2003).

$$V_{\text{VTTREF}} - 40 \text{ mV} < V_{\text{VTT}} < V_{\text{VTTREF}} + 40 \text{ mV} \quad (1)$$

The specification itself indicates that VTT must keep track of VTTREF for proper signal conditioning.

The TPS51200 ensures the regulator output voltage to be as shown in Equation 2, which applies to both DC and AC conditions.

$$V_{\text{VTTREF}} - 25 \text{ mV} < V_{\text{VTT}} < V_{\text{VTTREF}} + 25 \text{ mV}$$

where

$$\bullet \quad -2 \text{ A} < I_{\text{VTT}} < 2 \text{ A} \quad (2)$$

The regulator output voltage is measured at the regulator side, not the load side. The tolerance is applicable to DDR, DDR2, DDR3, DDR3L, Low Power DDR3, and DDR4 applications (see Table 1 for detailed information). To meet the stability requirement, a minimum output capacitance of 20 μF is needed. Considering the actual tolerance on the MLCC capacitors, three 10- μF ceramic capacitors sufficiently meet the VTT accuracy requirement.

Table 1. DDR, DDR2, DDR3 and LP DDR3 Termination Technology

	DDR	DDR2	DR3	LOW POWER DDR3
FSB Data Rates	200, 266, 333, and 400 MHz	400, 533, 677, and 800 MHz	800, 1066, 1330, and 1600 MHz	
Termination	Motherboard termination to VTT for all signals	On-die termination for data group. VTT termination for address, command and control signals	On-die termination for data group. VTT termination for address, command and control signals	
Termination Current Demand	Maximum source/sink transient currents of up to 2.6 A to 2.9 A	Not as demanding	Not as demanding	
		Only 34 signals (address, command, control) tied to VTT	Only 34 signals (address, command, control) tied to VTT	
		ODT handles data signals	ODT handles data signals	
		Less than 1-A of burst current	Less than 1-A of burst current	
Voltage Level	2.5-V Core and I/O 1.25-V VTT	1.8-V Core and I/O 0.9-V VTT	1.5-V Core and I/O 0.75-V VTT	1.2-V Core and I/O 0.6-V VTT

The TPS51200 uses transconductance (g_M) to drive the LDO. The transconductance and output current of the device determine the voltage droop between the reference input and the output regulator. The typical transconductance level is 250 S at 2 A and changes with respect to the load in order to conserve the quiescent current (that is, the transconductance is very low at no load condition). The (g_M) LDO regulator is a single pole system. Only the output capacitance determines the unity gain bandwidth for the voltage loop, as a result of the bandwidth nature of the transconductance (see Equation 3).

$$f_{\text{UGBW}} = \frac{g_M}{2 \times \pi \times C_{\text{OUT}}}$$

where

- f_{UGBW} is the unity gain bandwidth
 - g_M is transconductance
 - C_{OUT} is the output capacitance
- (3)

Consider these two limitations to this type of regulator that come from the output bulk capacitor requirement. In order to maintain stability, the zero location contributed by the ESR of the output capacitors must be greater than the –3-dB point of the current loop. This constraint means that higher ESR capacitors should not be used in the design. In addition, the impedance characteristics of the ceramic capacitor should be well understood in order to prevent the gain peaking effect around the transconductance (g_M) –3-dB point because of the large ESL, the output capacitor and parasitic inductance of the VO pin voltage trace.

7.3.12 REFOUT (V_{REF}) Consideration for DDR2 Applications

During TPS51200 tracking start-up, the REFIN voltage follows the rise of the VDDQ rail through a voltage divider, and REFOUT (V_{REF}) follows REFIN once the REFIN voltage is greater than 0.39 V. When the REFIN voltage is lower than 0.39 V, V_{REF} is 0 V.

The JEDEC *DDR2 SDRAM Standard* ([JESD79-2E](#)) states that V_{REF} must track VDDQ/2 within ±0.3 V accuracy during the start-up period. To allow the TPS51200

device to meet the JEDEC DDR2 specification, a resistor divider can be used to provide the V_{REF} signal to the DIMM. The resistor divider ratio is 0.5 to ensure that the V_{REF} voltage equals VDDQ/2.

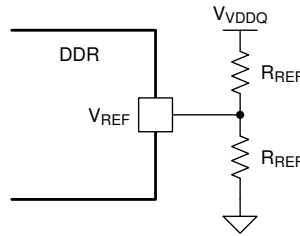


Figure 23. Resistor Divider Circuit

When selecting the resistor value, consider the impact of the leakage current from the DIMM V_{REF} pin on the reference voltage. Use [Equation 4](#) to calculate resistor values.

$$R_{REF} \leq \frac{2 \times \Delta V_{REF}}{I_{REF}}$$

where

- R_{REF} is the resistor value
- ΔV_{REF} is the V_{REF} DC variation requirement
- I_{REF} is the maximum total V_{REF} leakage current from DIMMs

(4)

Consider the MT47H64M16 DDR2 SDRAM component from Micron as an example. The [MT47H64M16](#) datasheet shows the maximum V_{REF} leakage current of each DIMM is ±2 μA, and V_{REF(DC)} variation must be within ±1% of VDDQ. In this DDR2 application, the VDDQ voltage is 1.8 V. Assuming one TPS51200 device needs to power 4 DIMMs, the maximum total V_{REF} leakage current is ±8 μA. Based on the calculations, the resistor value should be lower than 4.5 kΩ. To ensure sufficient margin, 100 Ω is the suggested resistor value. With two 100-Ω resistors, the maximum V_{REF} variation is 0.4 mV, and the power loss on each resistor is 8.1 mW.

7.4 Device Functional Modes

7.4.1 Low Input Voltage Applications

TPS51200 can be used in an application system that offers either a 2.5-V rail or a 3.3-V rail. If only a 5-V rail is available, consider using the [TPS51100](#) device as an alternative. The TPS51200 device has a minimum input voltage requirement of 2.375 V. If a 2.5-V rail is used, ensure that the absolute minimum voltage (both DC and transient) at the device pin is be 2.375 V or greater. The voltage tolerance for a 2.5-V rail input is between –5% and 5% accuracy, or better.

7.4.2 S3 and Pseudo-S5 Support

The TPS51200 provides S3 support by an EN function. The EN pin could be connected to an SLP_S3 signal in the end application. Both REFOUT and VO are on when EN = high (S0 state). REFOUT is maintained while VO is turned off and discharged via an internal discharge MOSFET when EN = low (S3 state). When EN = low and the REFIN voltage is less than 0.390 V, TPS51200 enters pseudo-S5 state. Both VO and REFOUT outputs are turned off and discharged to GND through internal MOSFETs when pseudo-S5 support is engaged (S4 or S5 state). [Figure 19](#) shows a typical start-up and shutdown timing diagram for an application that uses S3 and pseudo-S5 support.

8 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

8.1 Application Information

8.2 Typical Application

This design example describes a 3.3- V_{IN} , DDR3 configuration.

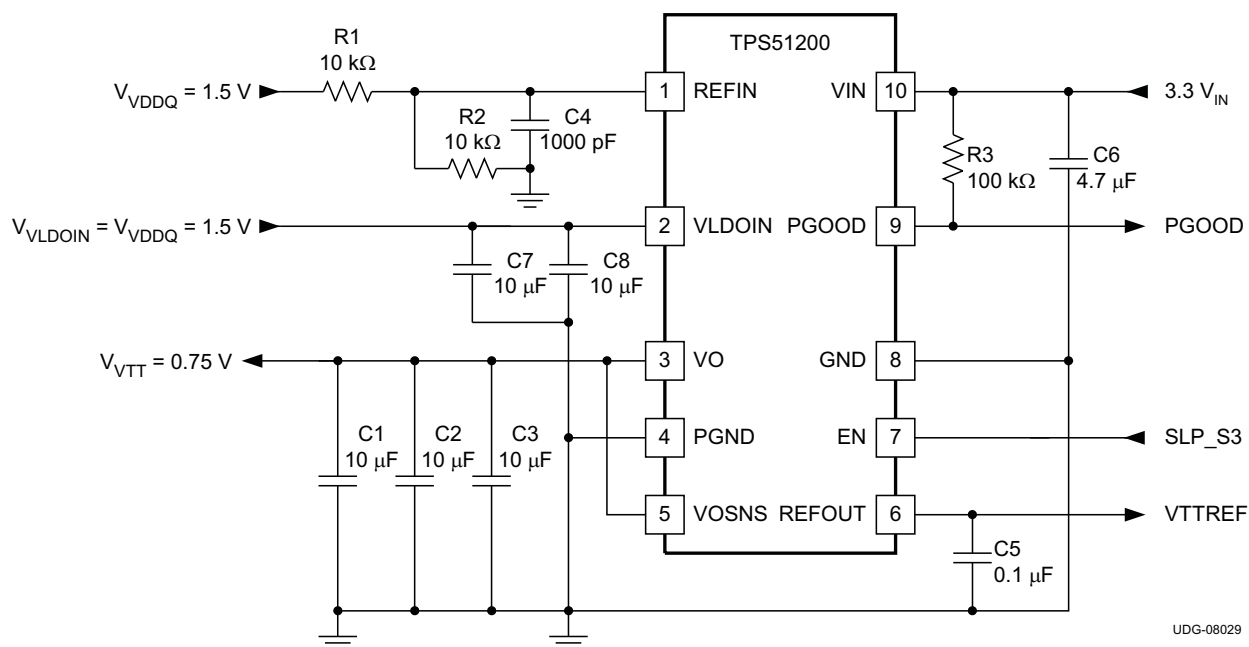


Figure 24. 3.3- V_{IN} , DDR3 Configuration

Table 2. 3.3- V_{IN} , DDR3 Application List of Materials

REFERENCE DESIGNATOR	DESCRIPTION	SPECIFICATION	PART NUMBER	MANUFACTURER
R1, R2	Resistor	10 kΩ		
R3		100 kΩ		
C1, C2, C3	Capacitor	10 μF, 6.3 V	GRM21BR70J106KE76L	Murata
C4		1000 pF		
C5		0.1 μF		
C6		4.7 μF, 6.3 V	GRM21BR60J475KA11L	Murata
C7, C8		10 μF, 6.3 V	GRM21BR70J106KE76L	Murata

8.2.1 Design Requirements

- $V_{IN} = 3.3\text{ V}$
- $V_{DDQ} = 1.5\text{ V}$
- $V_{VLDOIN} = V_{VDDQ} = 1.5\text{ V}$
- $V_{VTT} = 0.75\text{ V}$

8.2.2 Detailed Design Procedure

8.2.2.1 Input Voltage Capacitor

Add a ceramic capacitor, with a value between 1.0- μF and 4.7- μF , placed close to the VIN pin, to stabilize the bias supply (2.5-V rail or 3.3-V rail) from any parasitic impedance from the supply.

8.2.2.2 VLDO Input Capacitor

Depending on the trace impedance between the VLDOIN bulk power supply to the device, a transient increase of source current is supplied mostly by the charge from the VLDOIN input capacitor. Use a 10- μF (or greater) ceramic capacitor to supply this transient charge. Provide more input capacitance as more output capacitance is used at the VO pin. In general, use one-half of the C_{OUT} value for input.

8.2.2.3 Output Capacitor

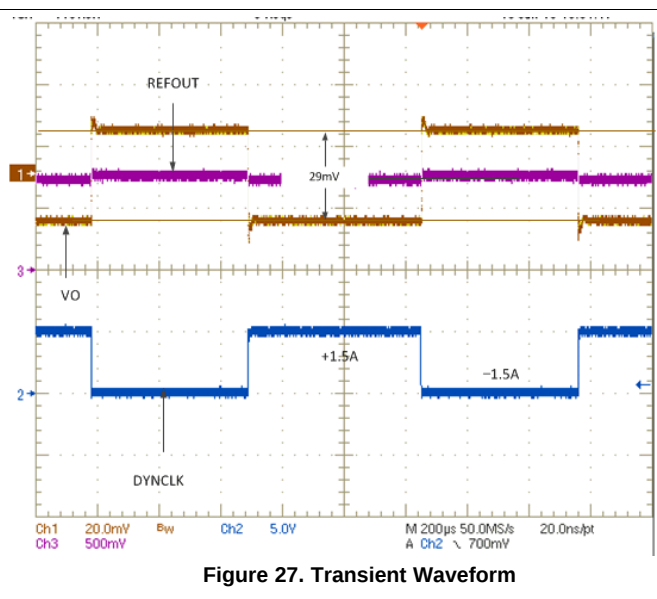
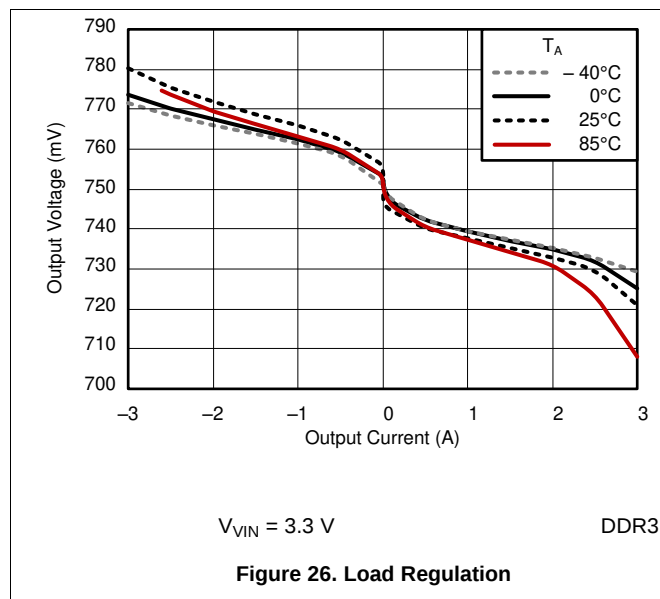
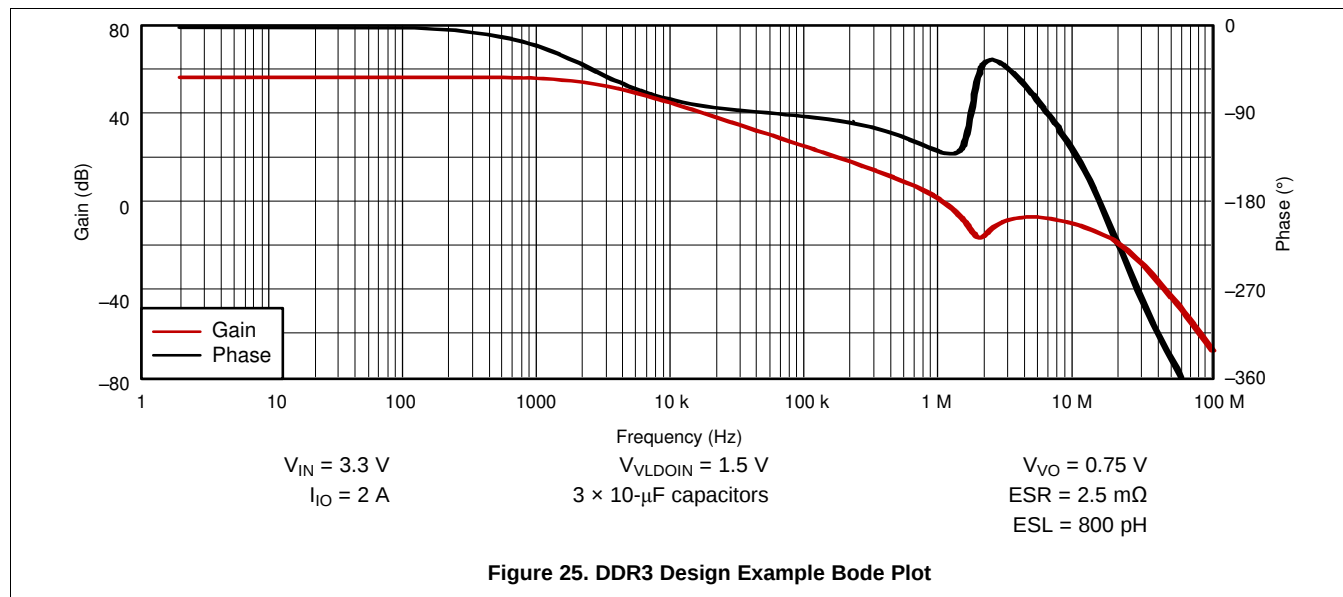
For stable operation, the total capacitance of the VO output pin must be greater than 20 μF . Attach three, 10- μF ceramic capacitors in parallel to minimize the effect of equivalent series resistance (ESR) and equivalent series inductance (ESL). If the ESR is greater than 2 m Ω , insert an RC filter between the output and the VOSNS input to achieve loop stability. The RC filter time constant should be almost the same as or slightly lower than the time constant of the output capacitor and its ESR.

8.2.3 Application Curves

Figure 25 shows the bode plot simulation for this DDR3 design example of the TPS51200 device.

The unity-gain bandwidth is approximately 1 MHz and the phase margin is 52°. The 0-dB level is crossed, the gain peaks because of the ESL effect. However, the peaking maintains a level well below 0 dB.

Figure 26 shows the load regulation and Figure 27 shows the transient response for a typical DDR3 configuration. When the regulator is subjected to ± 1.5 -A load step and release, the output voltage measurement shows no difference between the dc and ac conditions.



8.3 System Examples

8.3.1 3.3- V_{IN} , DDR2 Configuration

This section describes a 3.3- V_{IN} , DDR2 configuration application.

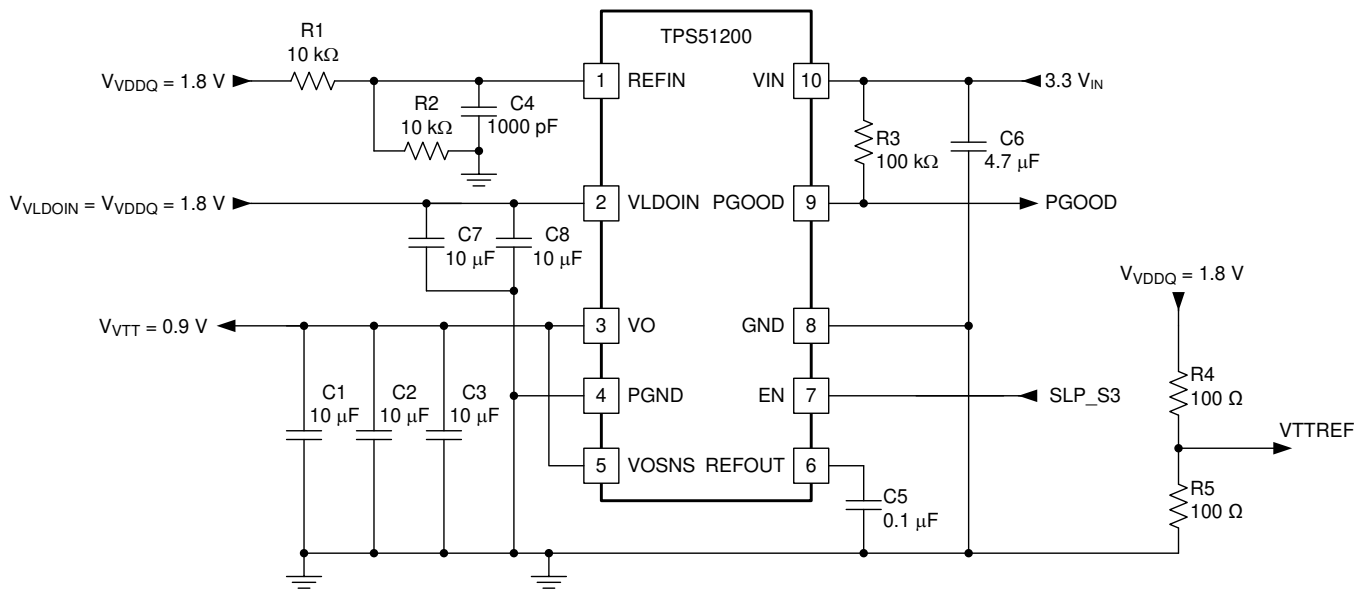


Figure 28. 3.3- V_{IN} , DDR2 Configuration

Table 3. 3.3- V_{IN} , DDR2 Configuration List of Materials

REFERENCE DESIGNATOR	DESCRIPTION	SPECIFICATION	PART NUMBER	MANUFACTURER
R1, R2	Resistor	10 kΩ		
R3		100 kΩ		
R4, R5		100 Ω		
C1, C2, C3	Capacitor	10 μF, 6.3 V	GRM21BR70J106KE76L	Murata
C4		1000 pF		
C5		0.1 μF		
C6		4.7 μF, 6.3 V	GRM21BR60J475KA11L	Murata
C7, C8		10 μF, 6.3 V	GRM21BR70J106KE76L	Murata

8.3.2 2.5- V_{IN} , DDR3 Configuration

This design example describes a 2.5- V_{IN} , DDR3 configuration application.

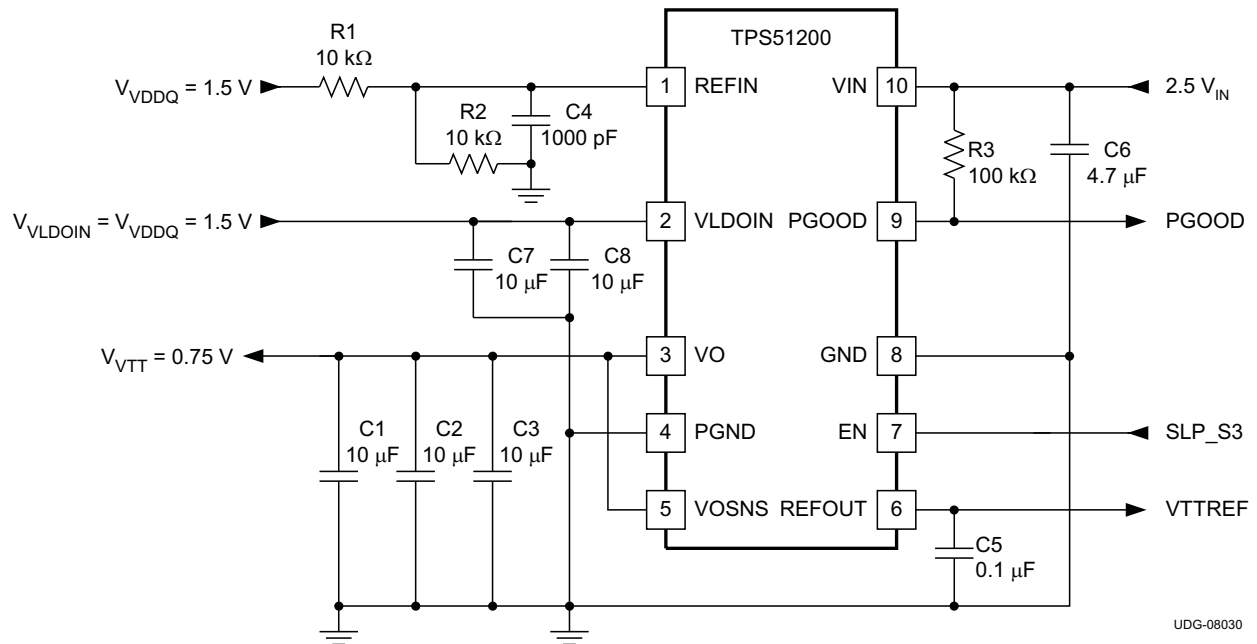


Figure 29. 2.5- V_{IN} , DDR3 Configuration

Table 4. 2.5- V_{IN} , DDR3 Configuration List of Materials

REFERENCE DESIGNATOR	DESCRIPTION	SPECIFICATION	PART NUMBER	MANUFACTURER
R1, R2	Resistor	10 kΩ		
R3		100 kΩ		
C1, C2, C3	Capacitor	10 μF, 6.3 V	GRM21BR70J106KE76L	Murata
C4		1000 pF		
C5		0.1 μF		
C6		4.7 μF, 6.3 V	GRM21BR60J475KA11L	Murata
C7, C8		10 μF, 6.3 V	GRM21BR70J106KE76L	Murata

8.3.3 3.3- V_{IN} , LP DDR3 or DDR4 Configuration

This example describes a 3.3- V_{IN} , LP DDR3 or DDR4 configuration application.

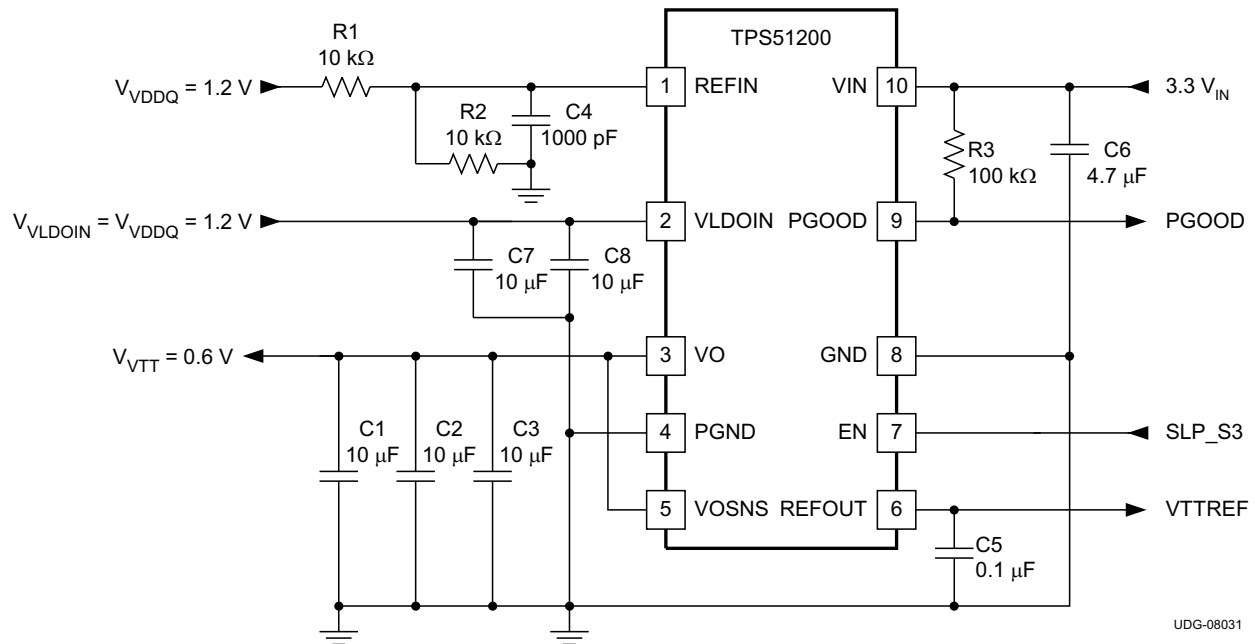


Figure 30. 3.3- V_{IN} , LP DDR3 or DDR4 Configuration

Table 5. 3.3- V_{IN} , LP DDR3 or DDR4 Configuration

REFERENCE DESIGNATOR	DESCRIPTION	SPECIFICATION	PART NUMBER	MANUFACTURER
R1, R2	Resistor	10 kΩ		
R3		100 kΩ		
C1, C2, C3	Capacitor	10 μF, 6.3 V	GRM21BR70J106KE76L	Murata
C4		1000 pF		
C5		0.1 μF		
C6		4.7 μF, 6.3 V	GRM21BR60J475KA11L	Murata
C7, C8		10 μF, 6.3 V	GRM21BR70J106KE76L	Murata

8.3.4 3.3- V_{IN} , DDR3 Tracking Configuration

This design example describes a 3.3- V_{IN} , DDR3 tracking configuration application.

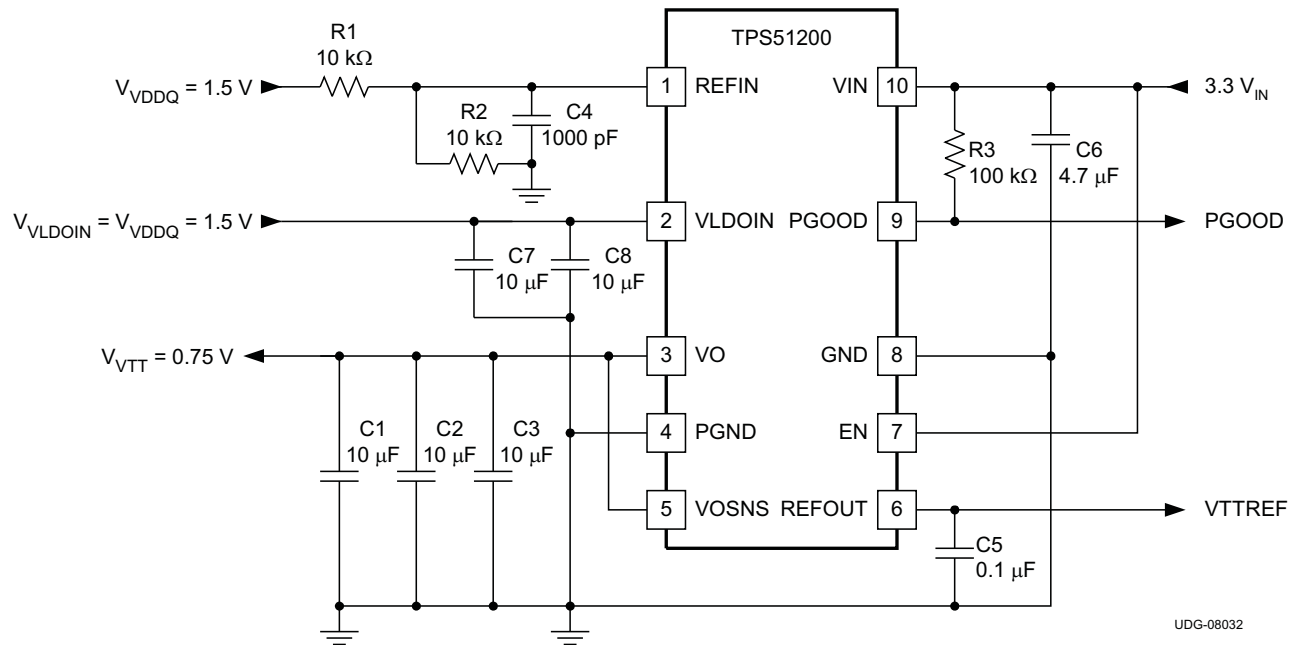


Figure 31. 3.3- V_{IN} , DDR3 Tracking Configuration

Table 6. 3.3- V_{IN} , DDR3 Tracking Configuration List of Materials

REFERENCE DESIGNATOR	DESCRIPTION	SPECIFICATION	PART NUMBER	MANUFACTURER
R1, R2	Resistor	10 kΩ		
R3		100 kΩ		
C1, C2, C3	Capacitor	10 μF, 6.3 V	GRM21BR70J106KE76L	Murata
C4		1000 pF		
C5		0.1 μF		
C6		4.7 μF, 6.3 V	GRM21BR60J475KA11L	Murata
C7, C8		10 μF, 6.3 V	GRM21BR70J106KE76L	Murata

8.3.5 3.3- V_{IN} , LDO Configuration

This example describes a 3.3- V_{IN} , LDO configuration application.

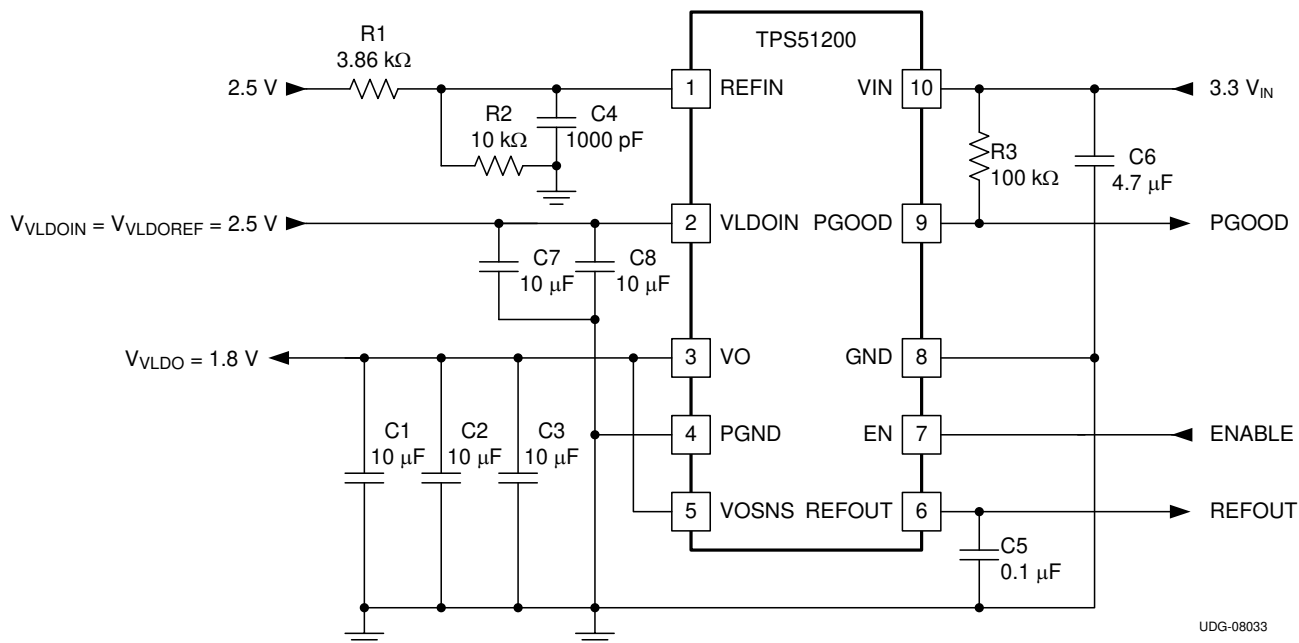


Figure 32. 3.3- V_{IN} , LDO Configuration

Table 7. 3.3- V_{IN} , LDO Configuration List of Materials

REFERENCE DESIGNATOR	DESCRIPTION	SPECIFICATION	PART NUMBER	MANUFACTURER
R1	Resistor	3.86 kΩ		
R2		10 kΩ		
R3		100 kΩ		
C1, C2, C3	Capacitor	10 μF, 6.3 V	GRM21BR70J106KE76L	Murata
C4		1000 pF		
C5		0.1 μF		
C6		4.7 μF, 6.3 V	GRM21BR60J475KA11L	Murata
C7, C8		10 μF, 6.3 V	GRM21BR70J106KE76L	Murata

8.3.6 3.3- V_{IN} , DDR3 Configuration with LFP

This design example describes a 3.3- V_{IN} , DDR3 configuration with LFP application.

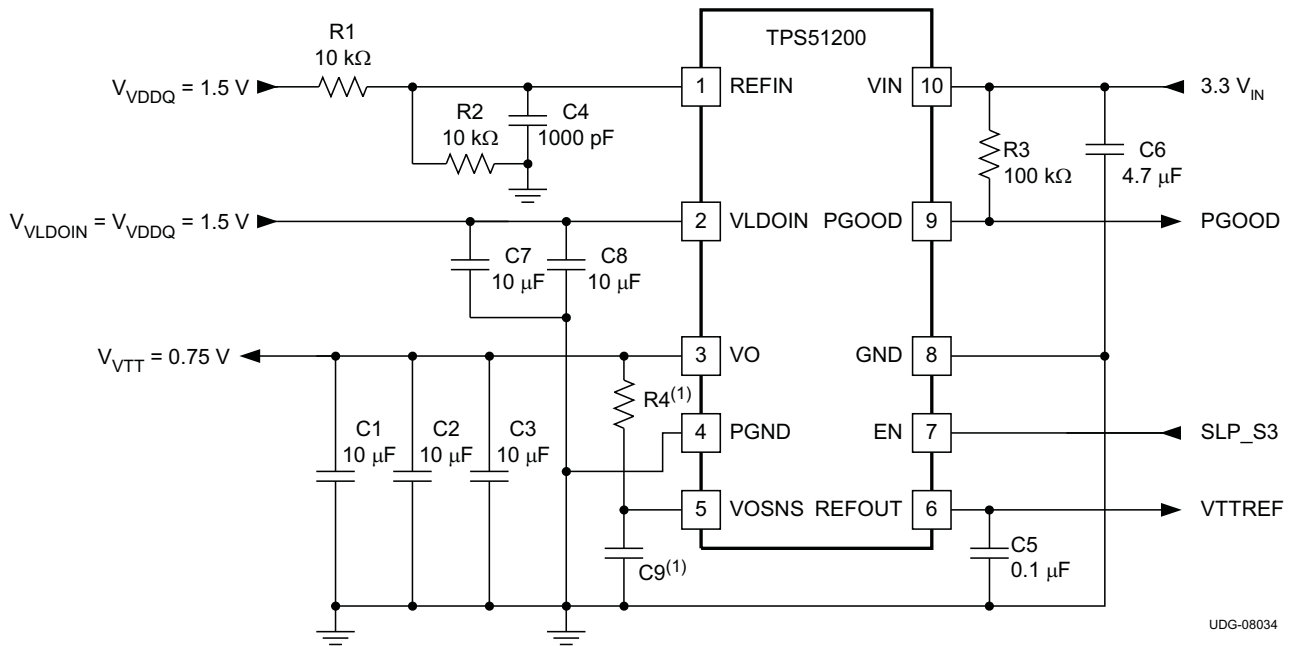


Figure 33. 3.3- V_{IN} , DDR3 Configuration with LFP

Table 8. 3.3- V_{IN} , DDR3 Configuration with LFP List of Materials

REFERENCE DESIGNATOR	DESCRIPTION	SPECIFICATION	PART NUMBER	MANUFACTURER
R1, R2	Resistor	10 kΩ		
R3		100 kΩ		
R4 ⁽¹⁾				
C1, C2, C3	Capacitor	10 μF, 6.3 V	GRM21BR70J106KE76L	Murata
C4		1000 pF		
C5		0.1 μF		
C6		4.7 μF, 6.3 V	GRM21BR60J475KA11L	Murata
C7, C8		10 μF, 6.3 V	GRM21BR70J106KE76L	Murata
C9 ⁽¹⁾				

(1) Choose values for R4 and C9 to reduce the parasitic effect of the trace (between VO and the output MLCCs) and the output capacitors (ESR and ESL).

9 Power Supply Recommendations

This device is designed to operate from an input bias voltage from 2.375 V to 3.5 V, with LDO input from 1.1 V to 3.5 V. Refer to [Figure 19](#) and [Figure 20](#) for recommended power-up sequence. Maintain a EN voltage equal or lower than V_{VIN} at all times. VLDOIN can ramp up earlier than VIN if the sequence in [Figure 19](#) and [Figure 20](#) cannot be used. The input supplies should be well regulated. VLDOIN decoupling capacitance of $2 \times 10 \mu\text{F}$ is recommended, and VIN decoupling capacitance of $1 \times 4.7 \mu\text{F}$ is recommended.

10 Layout

10.1 Layout Guidelines

Consider the following points before starting the TPS51200 device layout design.

- Place the input capacitors as close to VDLOIN pin as possible with short and wide connection.
- Place the output capacitor as close to VO pin as possible with short and wide connection. Place a ceramic capacitor with a value of at least 10- μF as close to VO pin if the rest of output capacitors need to be placed on the load side.
- Connect the VOSNS pin to the positive node of output capacitors as a separate trace. In DDR VTT application, connect the VO sense trace to DIMM side to ensure the VTT voltage at DIMM side is well regulated.
- Consider adding low-pass filter at VOSNS if the VO sense trace is very long.
- Connect the GND pin and PGND pin to the thermal pad directly.
- TPS51200 uses its thermal pad to dissipate heat. In order to effectively remove heat from TPS51200 package, place numerous ground vias on the thermal pad. Use large ground copper plane, especially the copper plane on surface layer, to pour over those vias on thermal pad.
- Consult the TPS51200EVM User's Guide ([SLUU323](#)) for detailed layout recommendations.

10.2 Layout Example

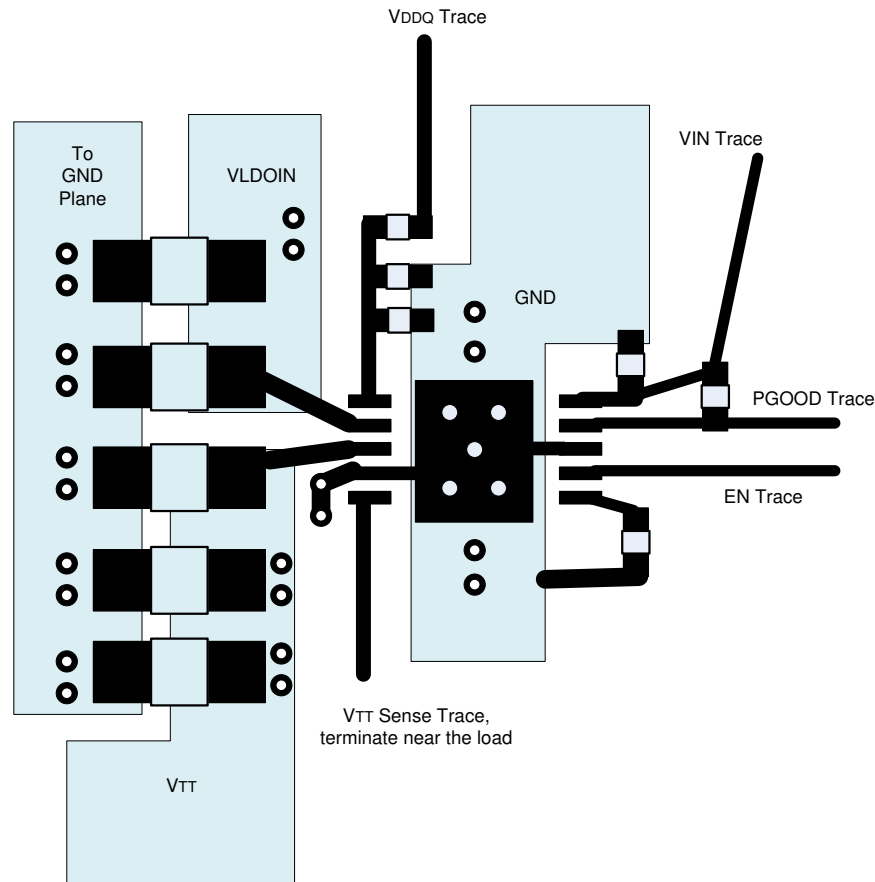


Figure 34. Layout Recommendation

10.3 Thermal Design Considerations

Because the TPS51200 is a linear regulator, the VO current flows in both source and sink directions, thereby dissipating power from the device. When the device is sourcing current, the voltage difference shown in [Equation 5](#) calculates the power dissipation.

$$P_{D_SRC} = (V_{VLDOIN} - V_{VO}) \times I_{O_SRC} \quad (5)$$

In this case, if the VLDOIN pin is connected to an alternative power supply lower than the V_{DDQ} voltage, overall power loss can be reduced. During the sink phase, the device applies the VO voltage across the internal LDO regulator. [Equation 6](#) calculates the power dissipation, P_{D_SNK} can be calculated by .

$$P_{D_SNK} = V_{VO} \times I_{SNK} \quad (6)$$

Because the device does not sink and source current at the same time and the I/O current may vary rapidly with time, the actual power dissipation should be the time average of the above dissipations over the thermal relaxation duration of the system. The current used for the internal current control circuitry from the VIN supply and the VLDOIN supply are other sources of power consumption. This power can be estimated as 5 mW or less during normal operating conditions and must be effectively dissipated from the package.

Thermal Design Considerations (continued)

Maximum power dissipation allowed by the package is calculated by [Equation 7](#).

$$P_{PKG} = \frac{T_{J(max)} - T_{A(max)}}{\theta_{JA}}$$

where

- $T_{J(max)}$ is 125°C
- $T_{A(max)}$ is the maximum ambient temperature in the system
- θ_{JA} is the thermal resistance from junction to ambient

(7)

NOTE

Because [Equation 7](#) demonstrates the effects of heat spreading in the ground plane, use it as a guideline only. Do not use [Equation 7](#) to estimate actual thermal performance in real application environments.

In an application where the device is mounted on PCB, TI strongly recommends using ψ_{JT} and ψ_{JB} , as explained in the section pertaining to estimating junction temperature in the *Semiconductor and IC Package Thermal Metrics* application report, [SPRA953](#). Using the thermal metrics ψ_{JT} and ψ_{JB} , as shown in the [Thermal Information](#) table, estimate the junction temperature with corresponding formulas shown in [Equation 8](#). The older θ_{JC} top parameter specification is listed as well for the convenience of backward compatibility.

$$T_J = T_T + \psi_{JT} \times P_D$$

(8)

$$T_J = T_B + \psi_{JB} \times P_D$$

where

- P_D is the power dissipation shown in [Equation 5](#) and [Equation 6](#)
- T_T is the temperature at the center-top of the IC package
- T_B is the PCB temperature measured 1-mm away from the thermal pad package on the PCB surface (see [Figure 36](#)).

(9)

NOTE

Both T_T and T_B can be measured on actual application boards using a thermo-gun (an infrared thermometer). For more information about measuring T_T and T_B , see the application report *Using New Thermal Metrics* ([SBVA025](#)).

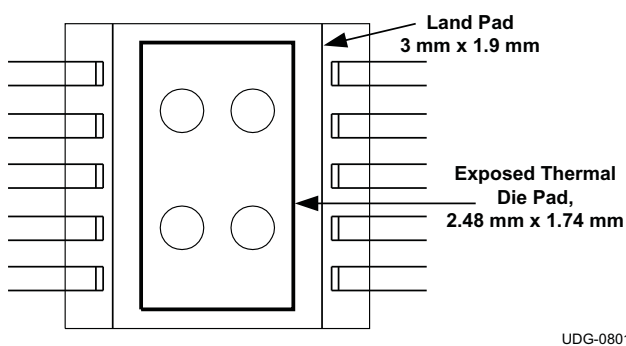


Figure 35. Recommended Land Pad Pattern

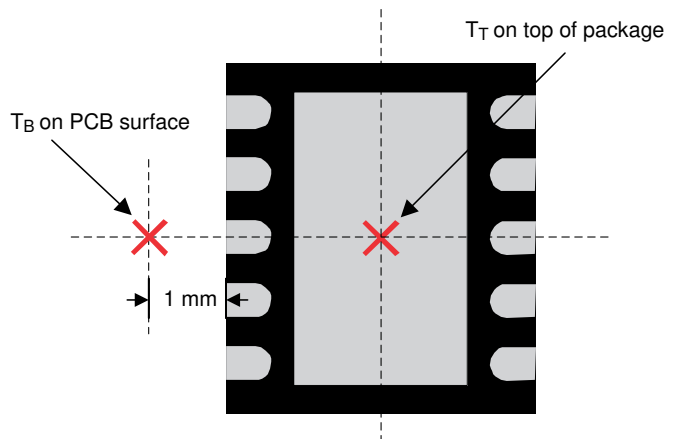


Figure 36. Package Thermal Measurement

11 器件和文档支持

11.1 器件支持

11.1.1 第三方产品免责声明

TI 发布的与第三方产品或服务有关的信息，不能构成与此类产品或服务或保修的适用性有关的认可，不能构成此类产品或服务单独或与任何 TI 产品或服务一起的表示或认可。

11.1.2 开发支持

11.1.2.1 评估模块

我们为您提供了评估模块 (EVM)，可帮助对使用 TPS51200 器件的电路进行初始性能评估。[TPS51200EVM](#) 评估模块以及相关的用户指南 ([SLUU323](#)) 可在德州仪器 (TI) 网站上的产品文件夹中获取，也可直接从 [TI 网上商店](#) 购买。

11.1.2.2 Spice 模型

分析模拟电路和系统的性能时，使用 SPICE 模型对电路性能进行计算机仿真非常有用。[单击此处](#)可获取 TPS51200 器件的 SPICE 模型。

11.2 文档支持

11.2.1 相关文档

- 《使用新的热指标》，[SBVA025](#)
- 《半导体和 IC 封装热指标》，[SPRA953](#)
- 《使用 TPS51200 EVM 灌电流/拉电流 DDR 终端稳压器》，[SLUU323](#)
- 有关 TPS51100 器件的更多信息，请参见 [ti.com](#) 上的产品文件夹。

11.3 社区资源

[TI E2E™ support forums](#) are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

11.4 商标

E2E is a trademark of Texas Instruments.

All other trademarks are the property of their respective owners.

11.5 静电放电警告



这些装置包含有限的内置 ESD 保护。存储或装卸时，应将导线一起截短或将装置放置于导电泡棉中，以防止 MOS 门极遭受静电损伤。

11.6 Glossary

[SLYZ022](#) — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

12 机械、封装和可订购信息

以下页面包含机械、封装和可订购信息。这些信息是指定器件的最新可用数据。数据如有变更，恕不另行通知，且不会对此文档进行修订。如需获取此数据表的浏览器版本，请查阅左侧的导航栏。

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
TPS51200DRCR	Active	Production	VSON (DRC) 10	3000 LARGE T&R	Yes	NIPDAU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	1200
TPS51200DRCR.A	Active	Production	VSON (DRC) 10	3000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	1200
TPS51200DRCR.B	Active	Production	VSON (DRC) 10	3000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	1200
TPS51200DRCRG4	Active	Production	VSON (DRC) 10	3000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	1200
TPS51200DRCT	Active	Production	VSON (DRC) 10	250 SMALL T&R	Yes	NIPDAU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	1200
TPS51200DRCT.A	Active	Production	VSON (DRC) 10	250 SMALL T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	1200
TPS51200DRCT.B	Active	Production	VSON (DRC) 10	250 SMALL T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	1200
TPS51200DRCTG4	Active	Production	VSON (DRC) 10	250 SMALL T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	1200

⁽¹⁾ **Status:** For more details on status, see our [product life cycle](#).

⁽²⁾ **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

⁽⁴⁾ **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "-" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF TPS51200 :

- Automotive : [TPS51200-Q1](#)
- Enhanced Product : [TPS51200-EP](#)

NOTE: Qualified Version Definitions:

- Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects
- Enhanced Product - Supports Defense, Aerospace and Medical Applications

TAPE AND REEL INFORMATION



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TPS51200DRCR	VSON	DRC	10	3000	330.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2
TPS51200DRCT	VSON	DRC	10	250	180.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2
TPS51200DRCT	VSON	DRC	10	250	180.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TPS51200DRCR	VSON	DRC	10	3000	367.0	367.0	35.0
TPS51200DRCT	VSON	DRC	10	250	210.0	185.0	35.0
TPS51200DRCT	VSON	DRC	10	250	210.0	185.0	35.0

GENERIC PACKAGE VIEW

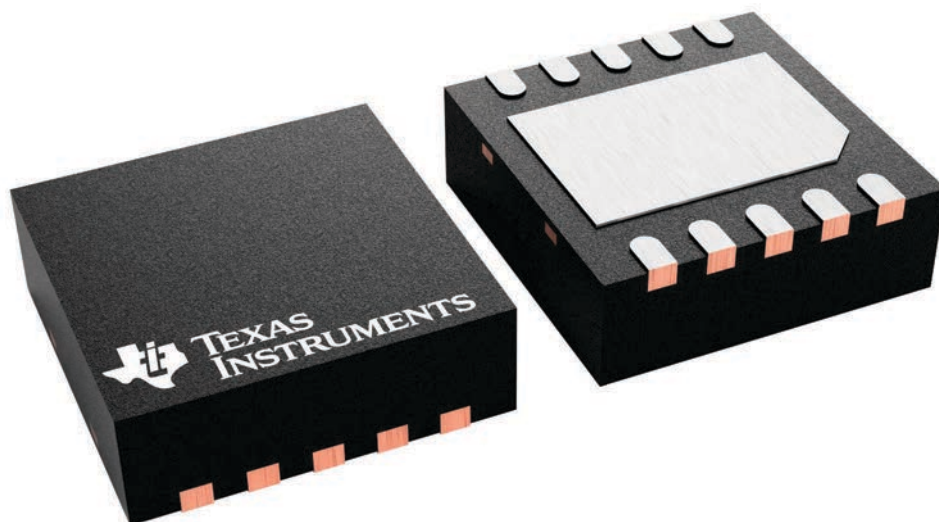
DRC 10

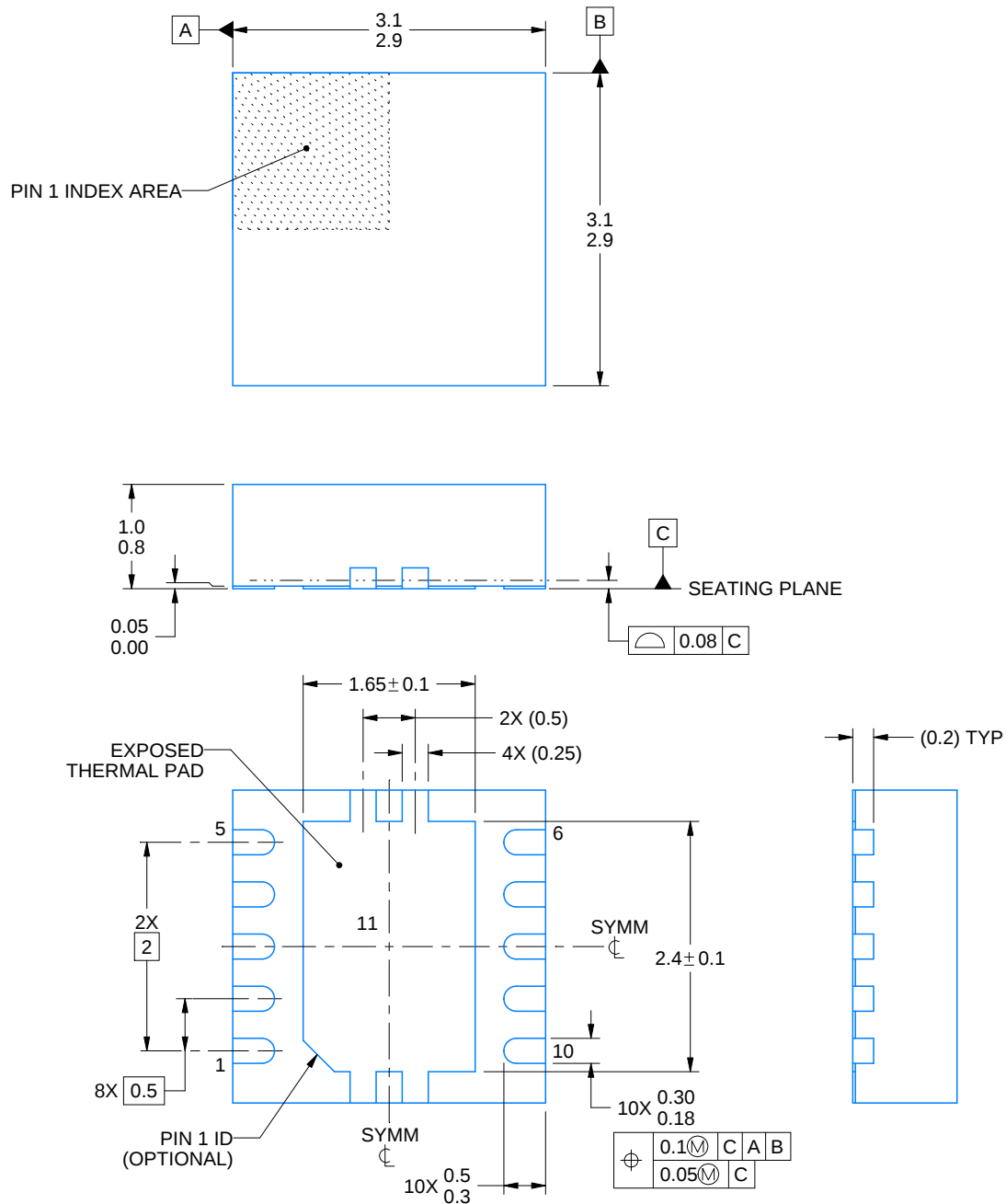
VSON - 1 mm max height

3 x 3, 0.5 mm pitch

PLASTIC SMALL OUTLINE - NO LEAD

This image is a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.





4218878/B 07/2018

NOTES:

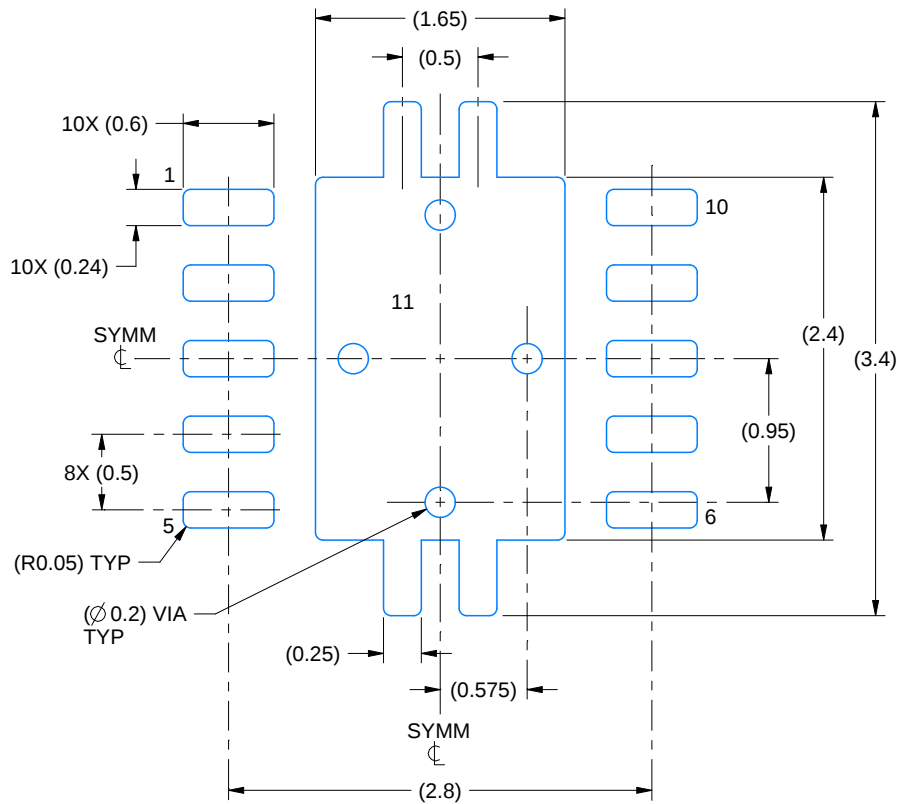
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for optimal thermal and mechanical performance.

EXAMPLE BOARD LAYOUT

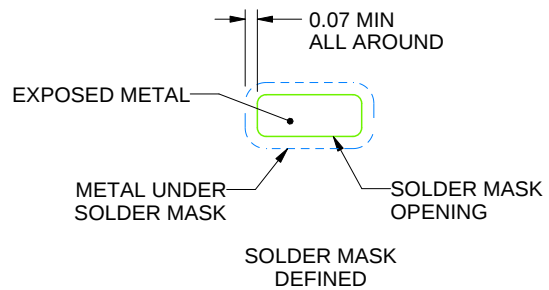
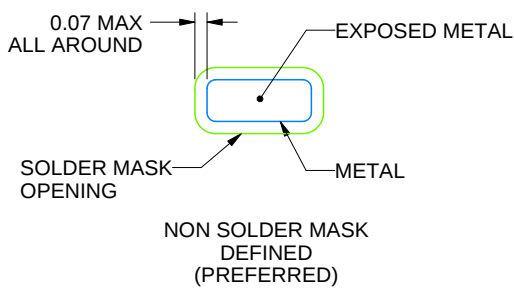
DRC0010J

VSON - 1 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:20X



SOLDER MASK DETAILS

4218878/B 07/2018

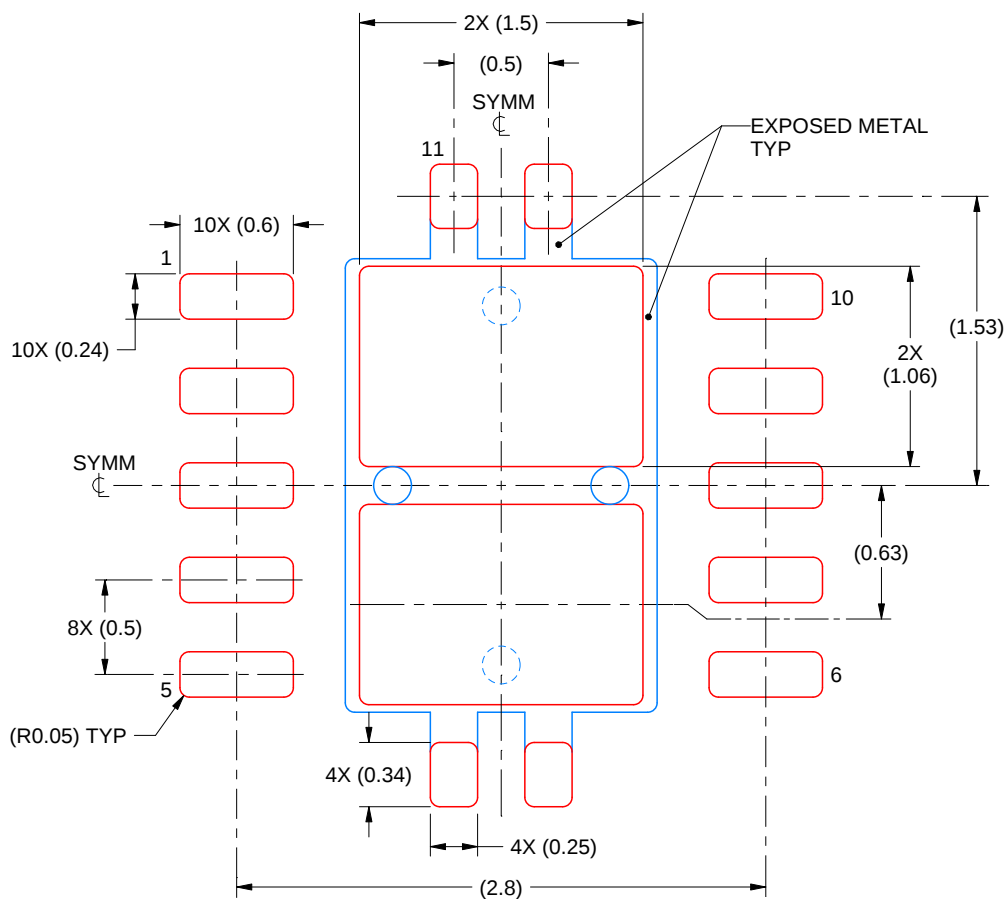
NOTES: (continued)

- This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/sluea271).
- Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.

DRC0010J

VSON - 1 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL

EXPOSED PAD 11:
80% PRINTED SOLDER COVERAGE BY AREA
SCALE:25X

4218878/B 07/2018

NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

重要通知和免责声明

TI“按原样”提供技术和可靠性数据（包括数据表）、设计资源（包括参考设计）、应用或其他设计建议、网络工具、安全信息和其他资源，不保证没有瑕疵且不做任何明示或暗示的担保，包括但不限于对适销性、某特定用途方面的适用性或不侵犯任何第三方知识产权的暗示担保。

这些资源可供使用 TI 产品进行设计的熟练开发人员使用。您将自行承担以下全部责任：(1) 针对您的应用选择合适的 TI 产品，(2) 设计、验证并测试您的应用，(3) 确保您的应用满足相应标准以及任何其他功能安全、信息安全、监管或其他要求。

这些资源如有变更，恕不另行通知。TI 授权您仅可将这些资源用于研发本资源所述的 TI 产品的相关应用。严禁以其他方式对这些资源进行复制或展示。您无权使用任何其他 TI 知识产权或任何第三方知识产权。您应全额赔偿因在这些资源的使用中对 TI 及其代表造成的任何索赔、损害、成本、损失和债务，TI 对此概不负责。

TI 提供的产品受 [TI 的销售条款](#) 或 [ti.com](#) 上其他适用条款/TI 产品随附的其他适用条款的约束。TI 提供这些资源并不会扩展或以其他方式更改 TI 针对 TI 产品发布的适用的担保或担保免责声明。

TI 反对并拒绝您可能提出的任何其他或不同的条款。

邮寄地址：Texas Instruments, Post Office Box 655303, Dallas, Texas 75265
版权所有 © 2025，德州仪器 (TI) 公司